

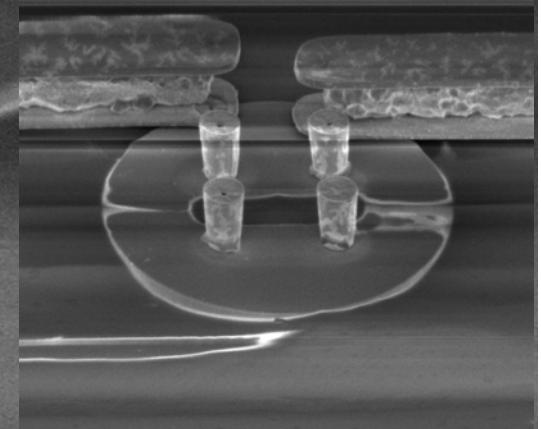
Active wavelength control of silicon micromechanical resonant modulators

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Outline

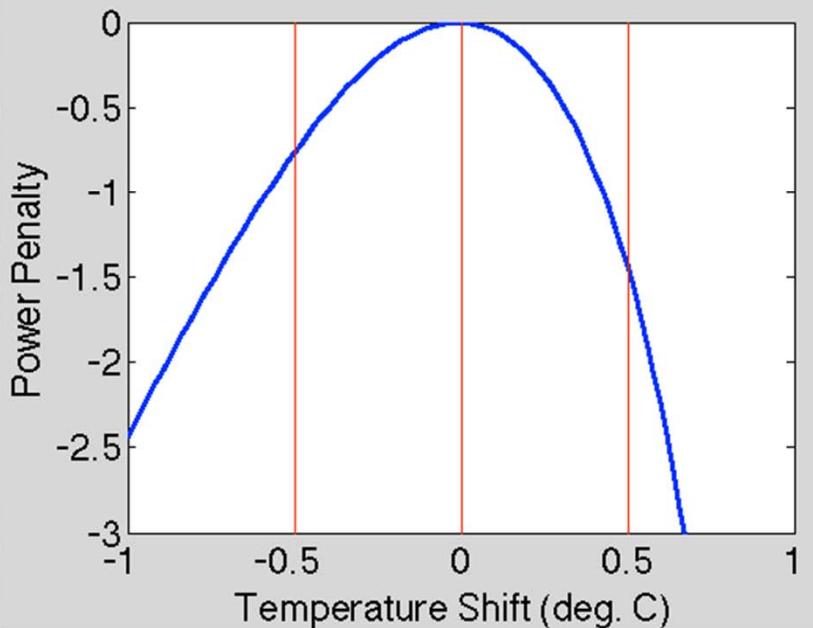
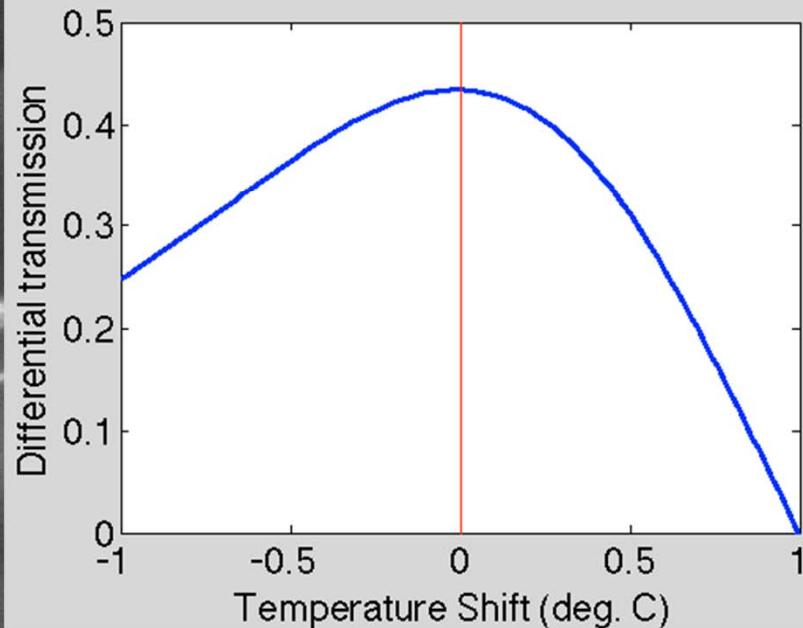
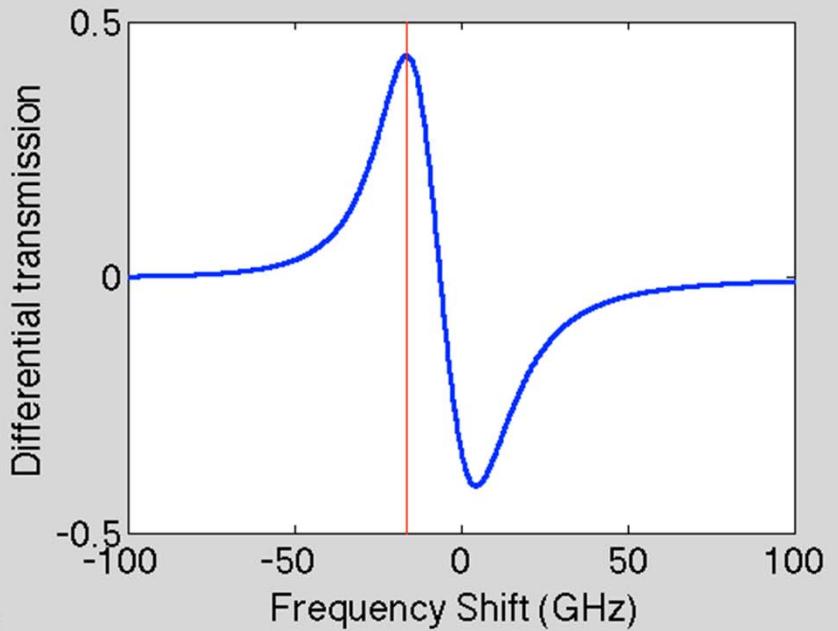
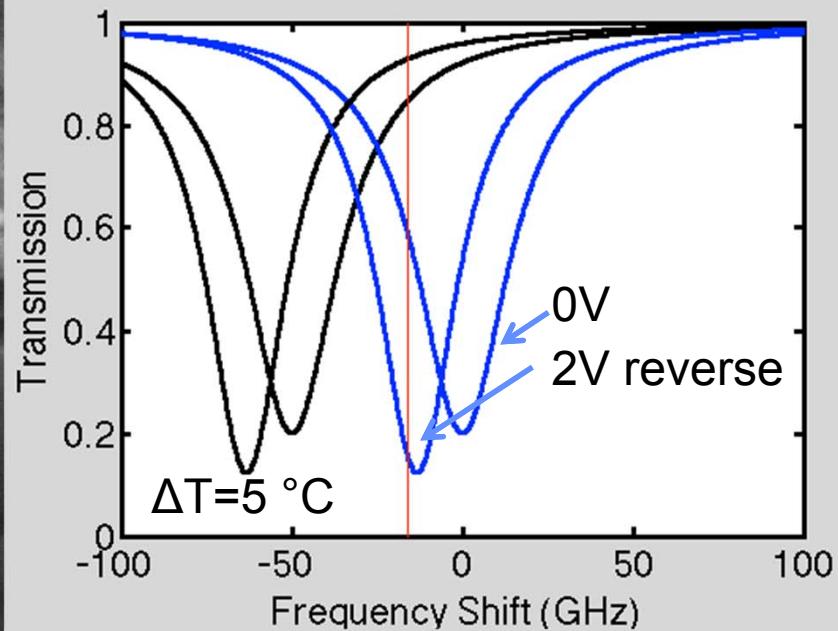
- Causes of resonant frequency variation, temperature range and accuracy requirements
- Method
- Experiments
- Conclusion

Causes of variations in resonant frequency

- Manufacturing Variations
- Temperature Variations
- Optical Power
- 1s density
- Is there aging?

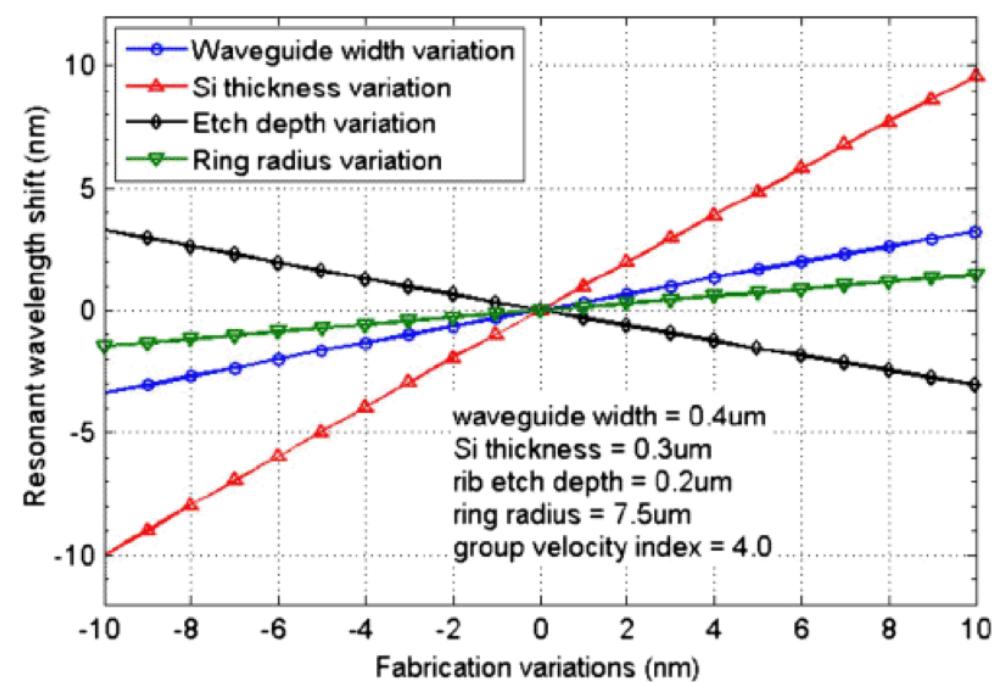
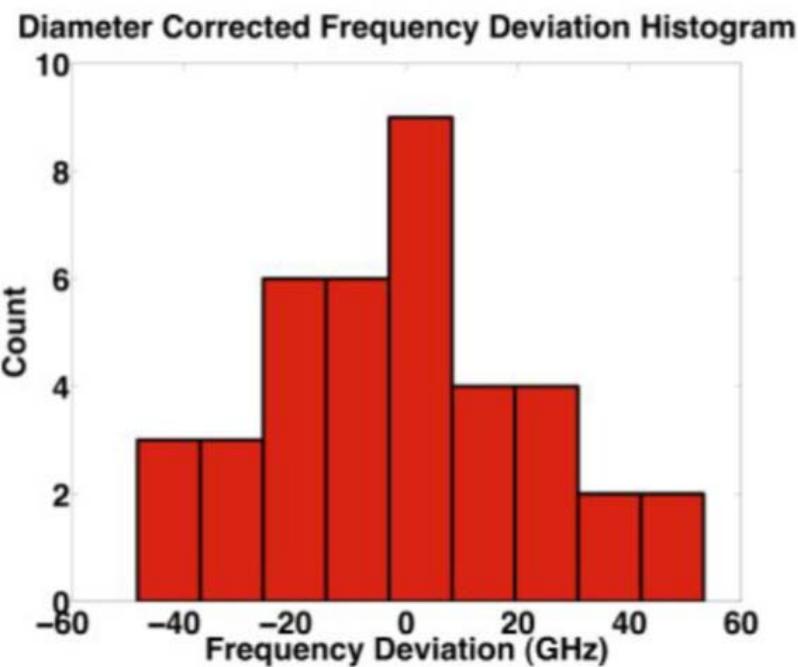
- Why bit errors to stabilize modulators?
 - Handles all sources of variations
 - It's what we care about

Optical Modulators: Effect on loss budget



Resonant frequency manufacturing accuracy

- Thickness variations of the silicon layer is dominant
- On-chip variation < 100 GHz

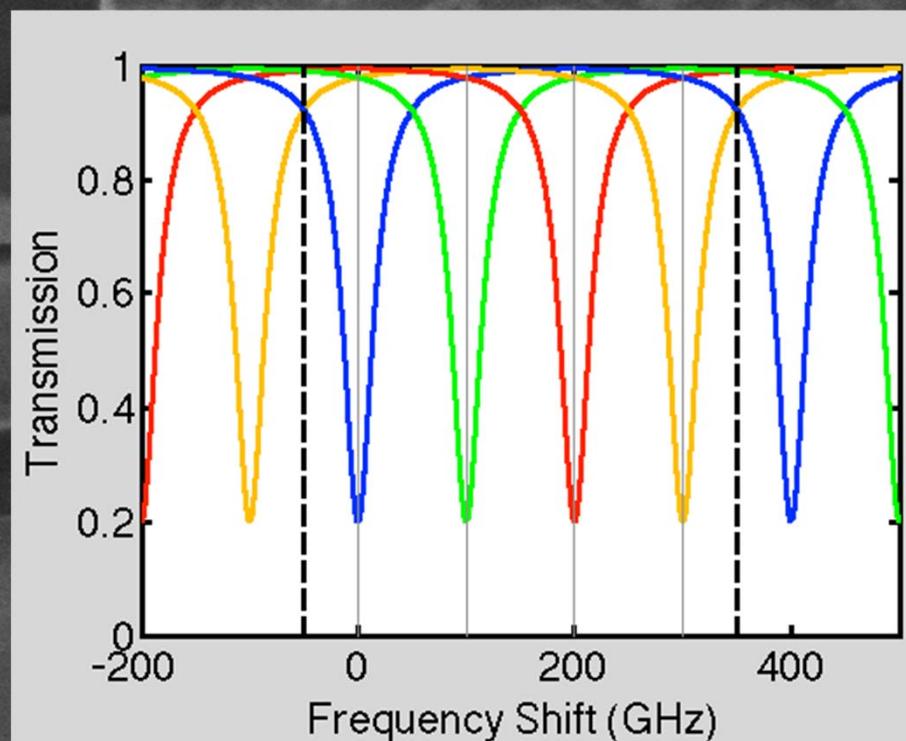


Krishnamoorthy et. al, IEEE Photonics J., 2011

Zortman et. al, Optics, Exp., 2011

Cyclical Channels reduces tuning range

- $FSR=N \times \text{channel spacing}$
- Maximum heating = channel spacing
 - $100\text{GHz} \rightarrow 10^\circ \text{ C}$
- Manufacturing
 - $100 \text{ GHz variation} \rightarrow 10\text{C}$
- **Total $\rightarrow 20\text{C}$ (worst case)**
- **Accuracy $\rightarrow 0.25\text{C}$**

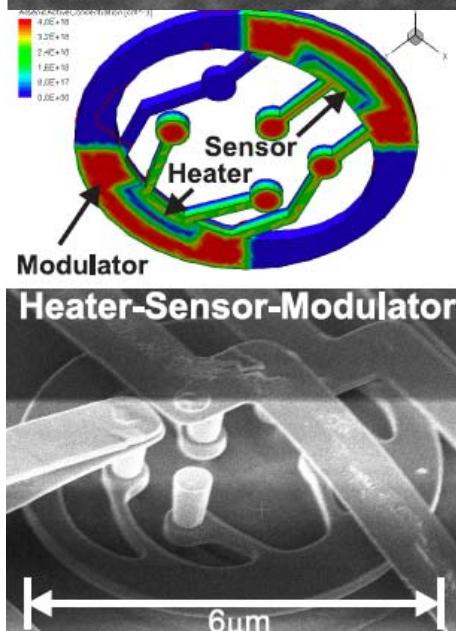


N. Binkert et al., ISCA 2011

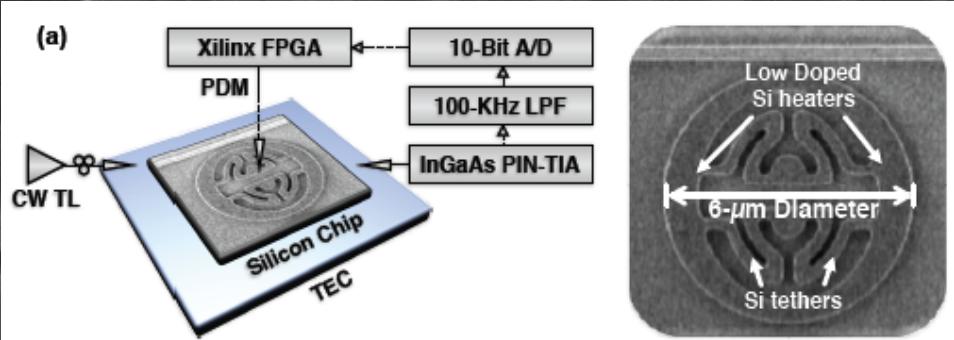
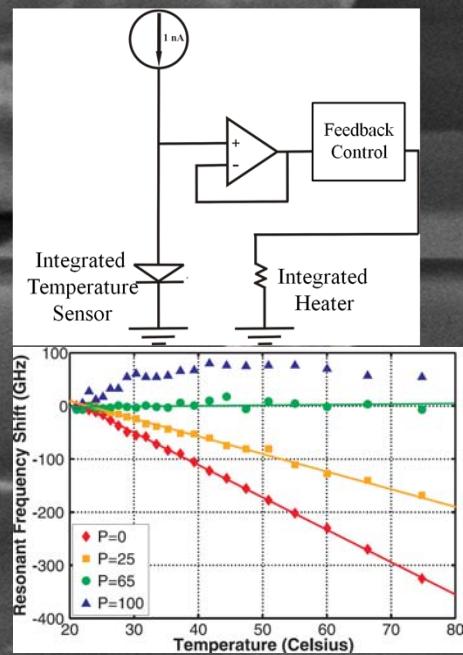
A. V. Krishnamoorthy et. al., IEEE Photonics Journal, 2011

M. Gorgas et. al., IEEE CICC, 2011

Previous closed loop control experiments stabilizing the resonant frequency

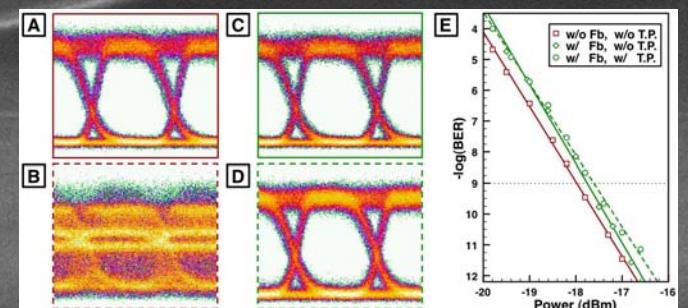
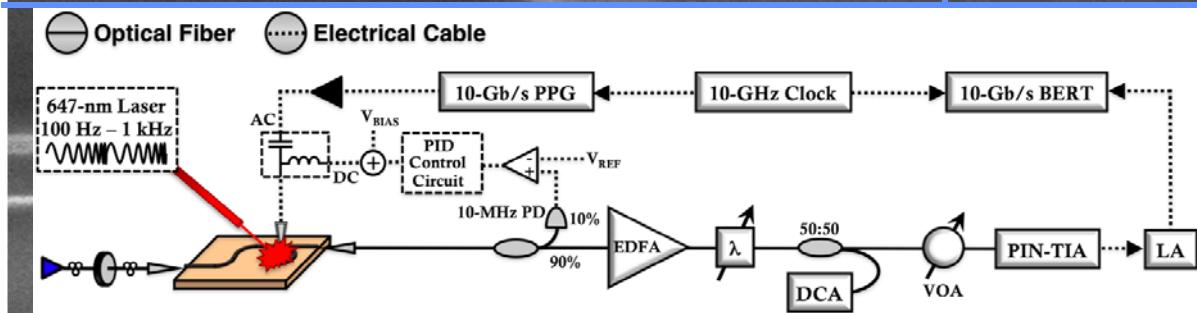


Resonator with temperature sensor, PID loop (DeRose CLEO2010)



Resonator with heater, without sensor (Timurdogan et. al., CLEO 2012),

External power measurement and feedback to lock wavelength

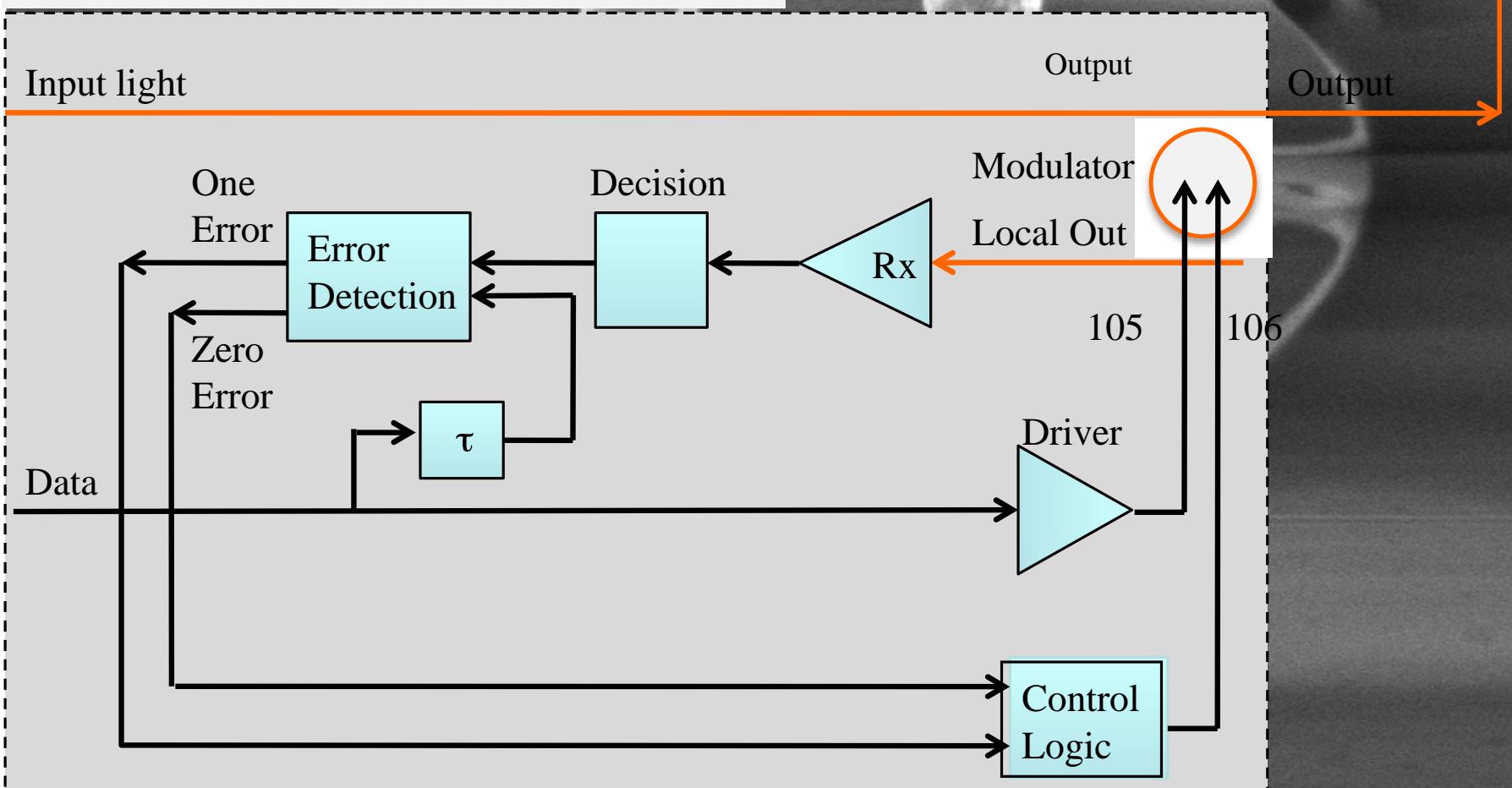
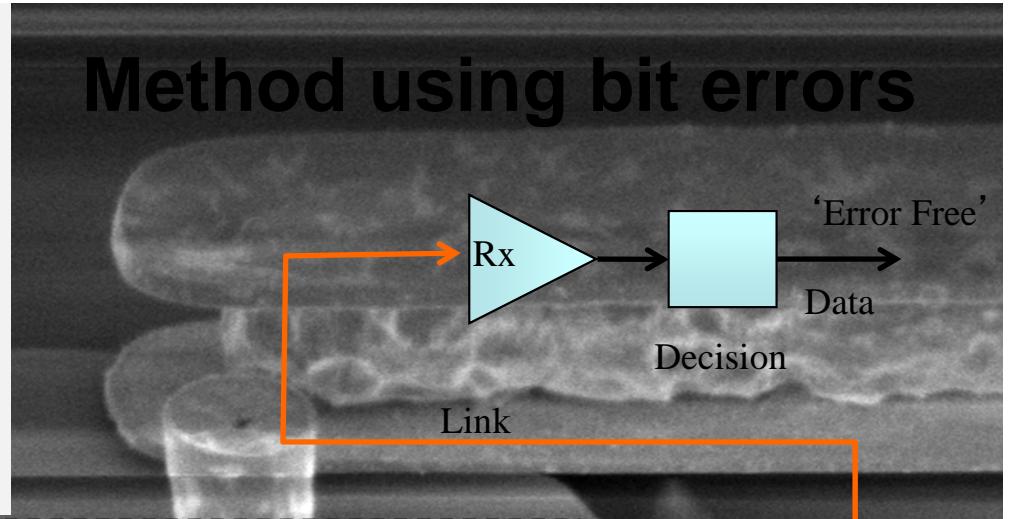


Modulator with bias induced temperature change monitoring mean optical power (Padmaraju, OFC 2012)

Idea

- Measure bit errors in a local receiver near the modulator
- Adjust heater to minimize local bit errors
- If local receiver has high noise floor, far-end receiver can be error free

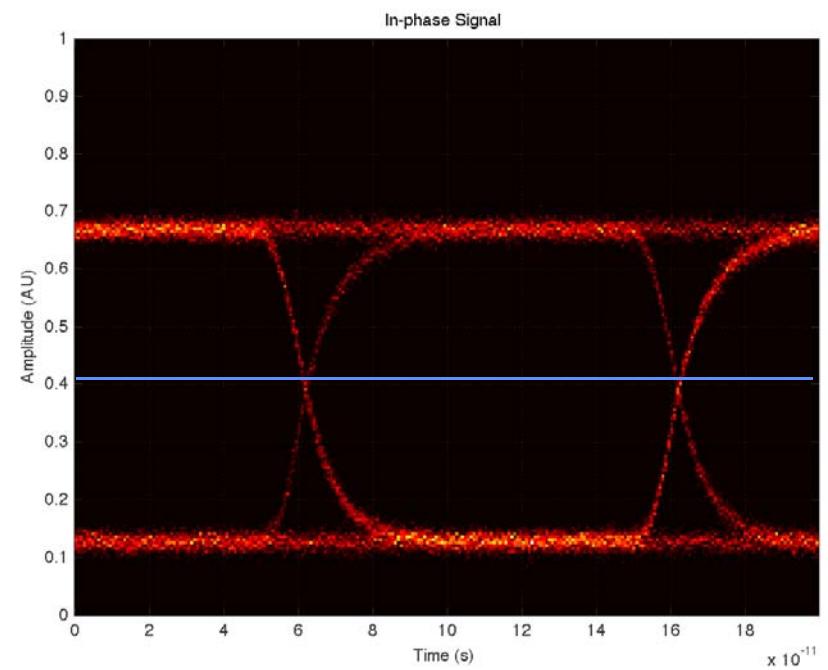
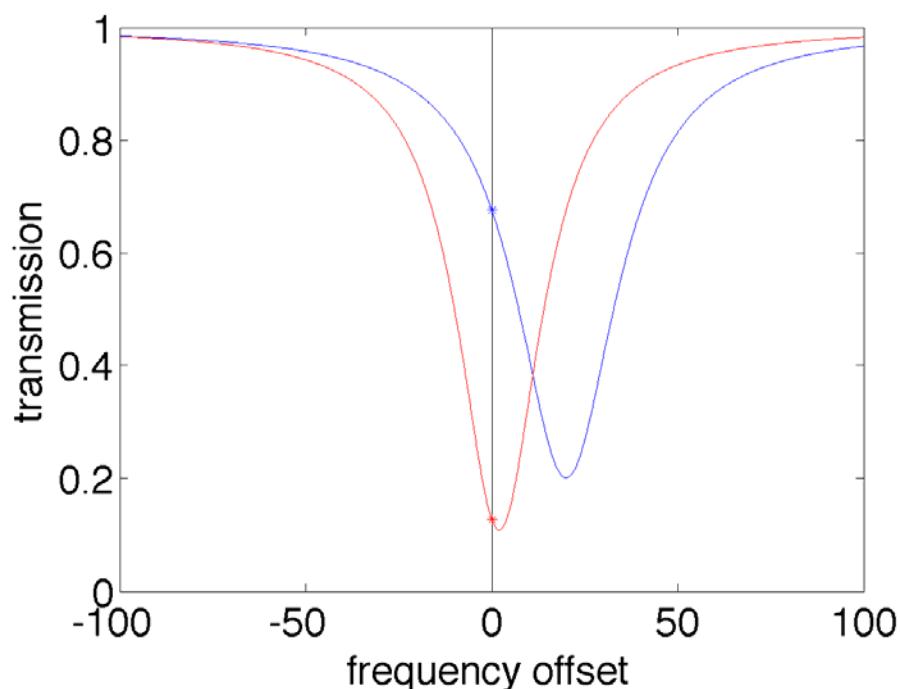
Method using bit errors



Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

-2 °C



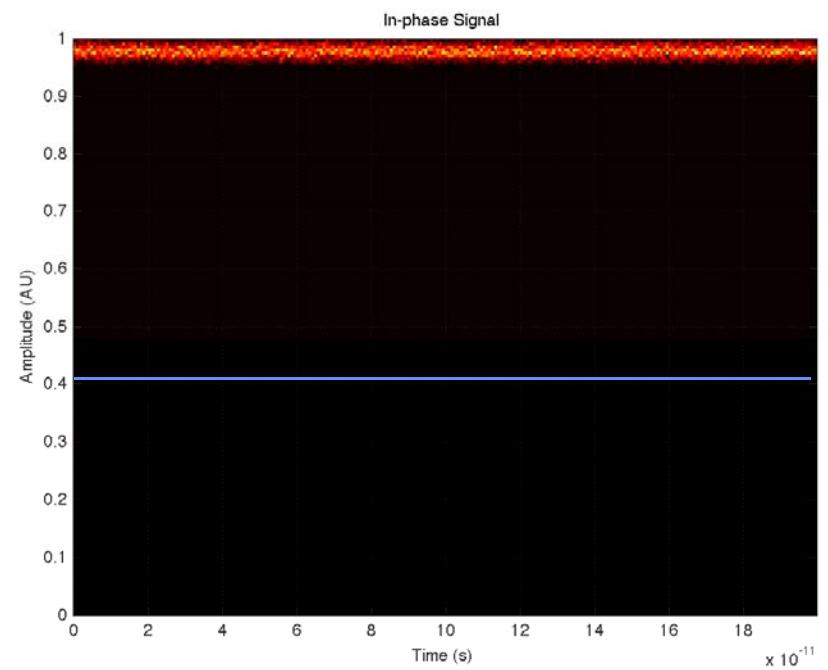
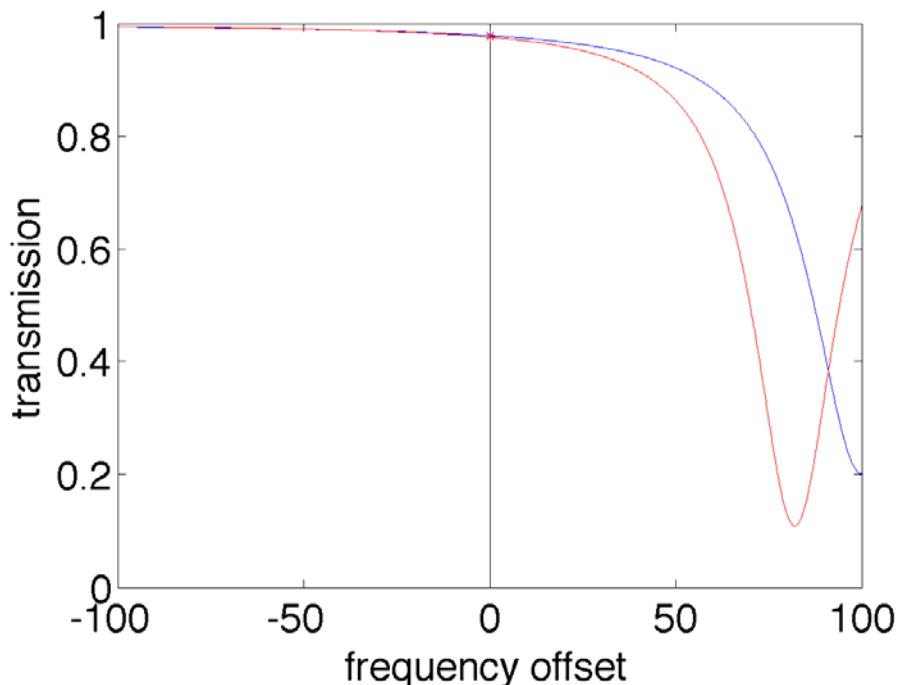
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

-10 °C



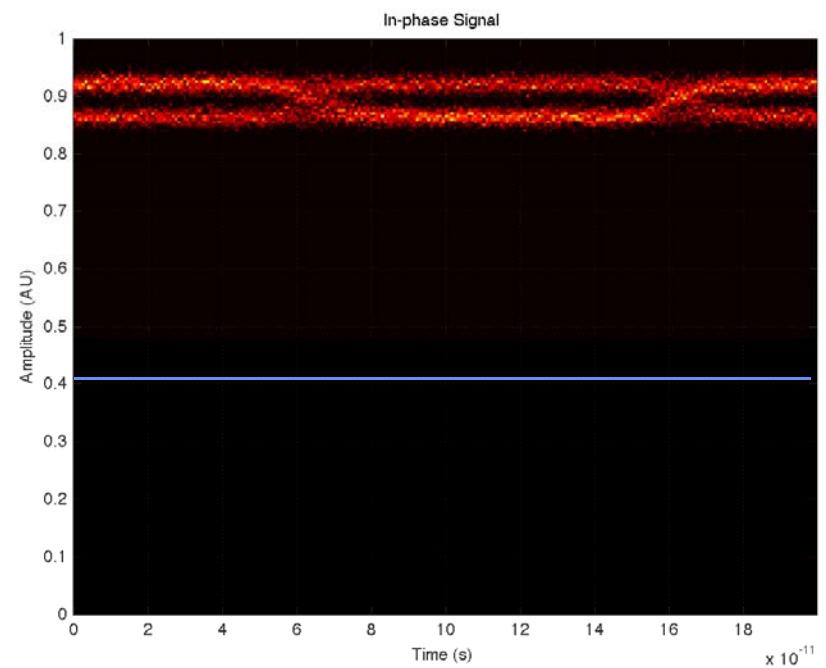
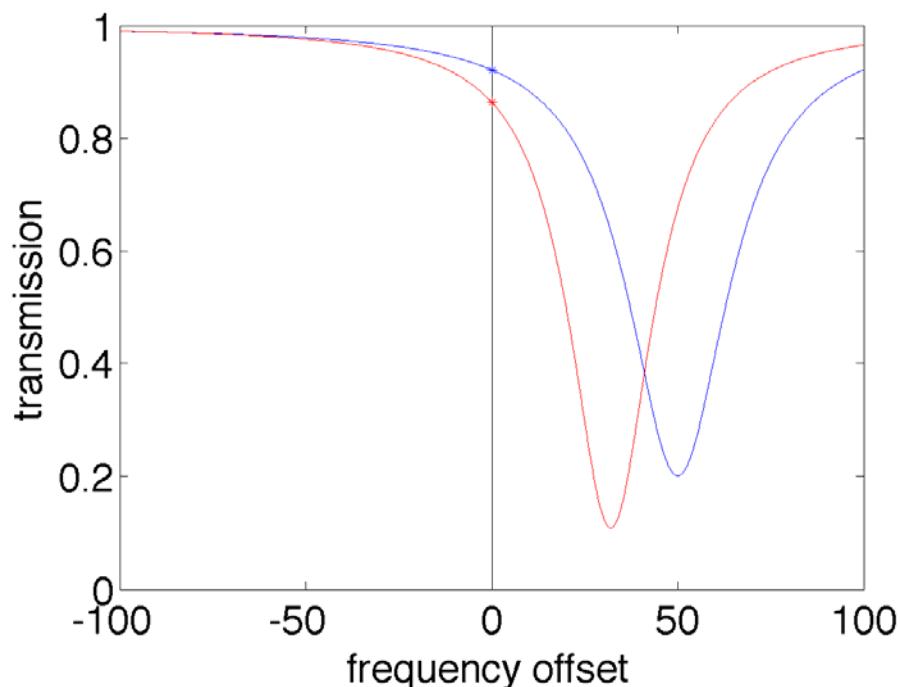
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

-5 °C



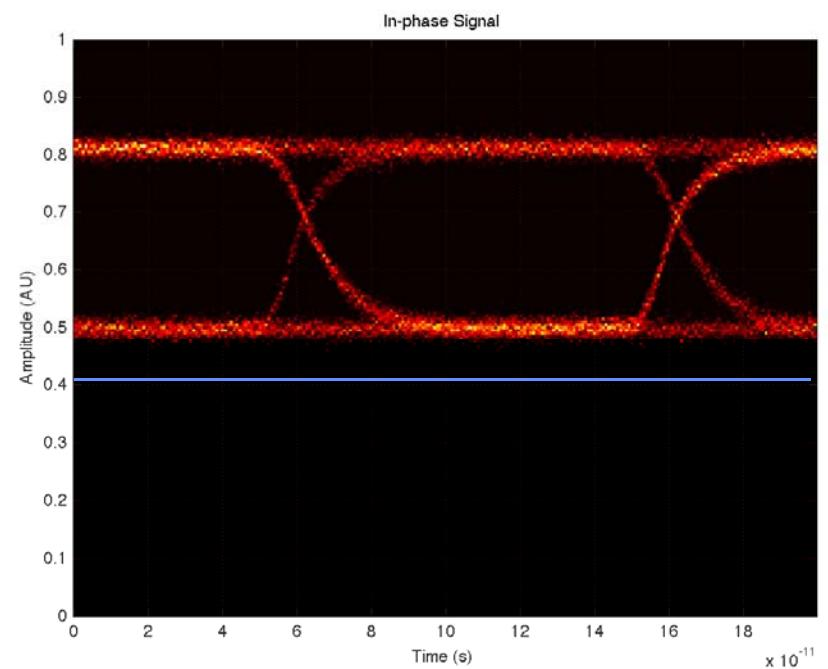
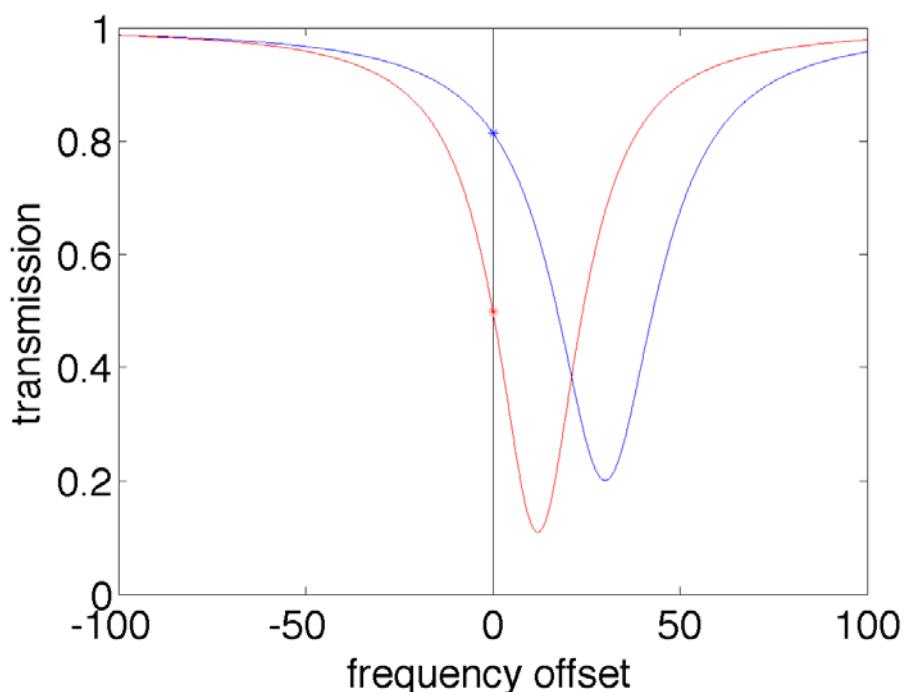
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

-3 °C



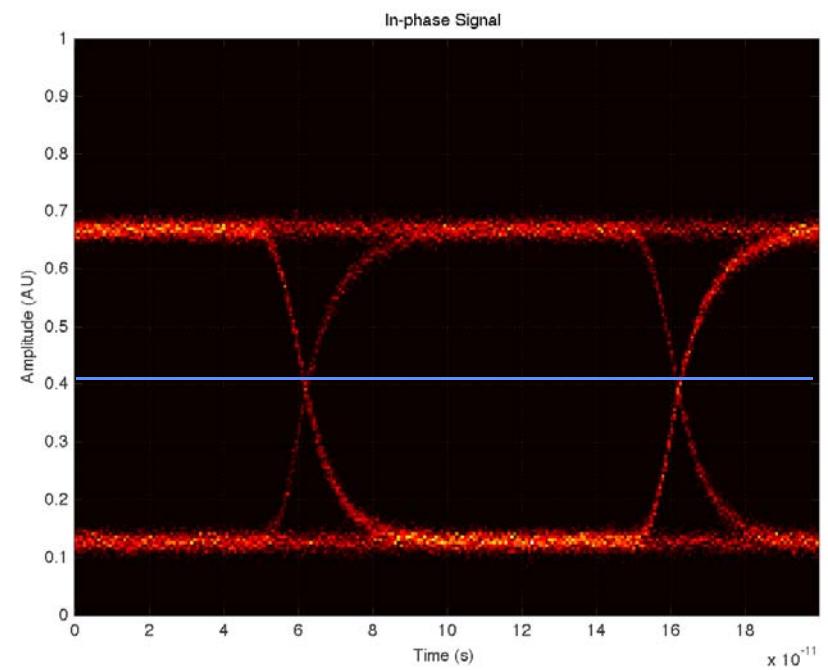
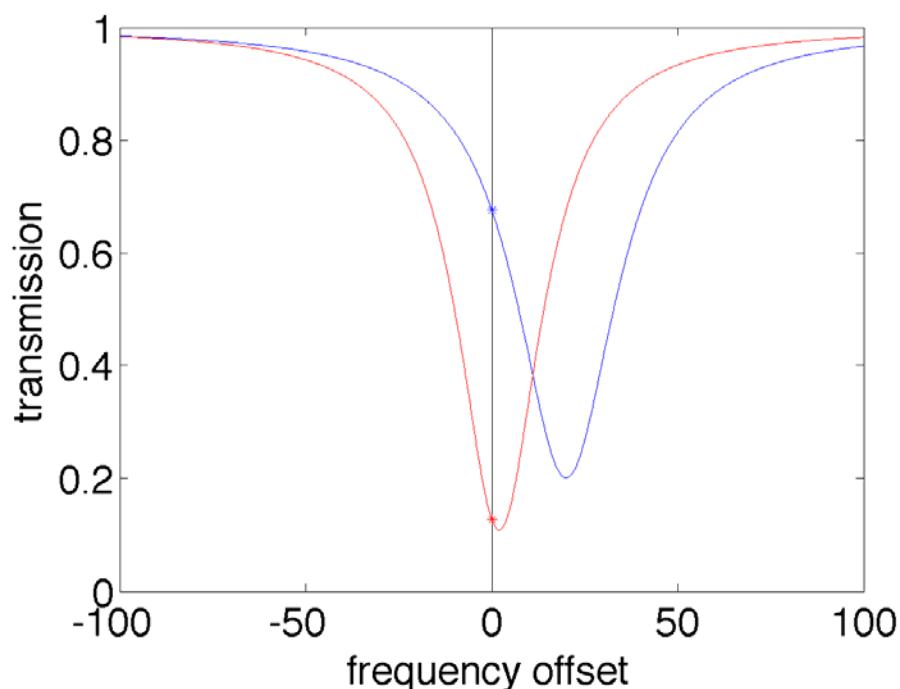
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

-2 °C



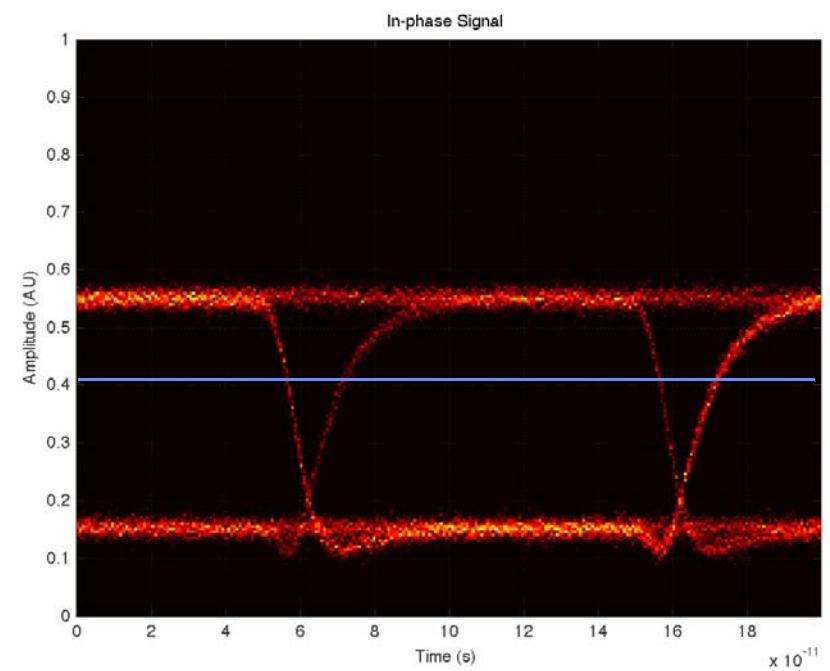
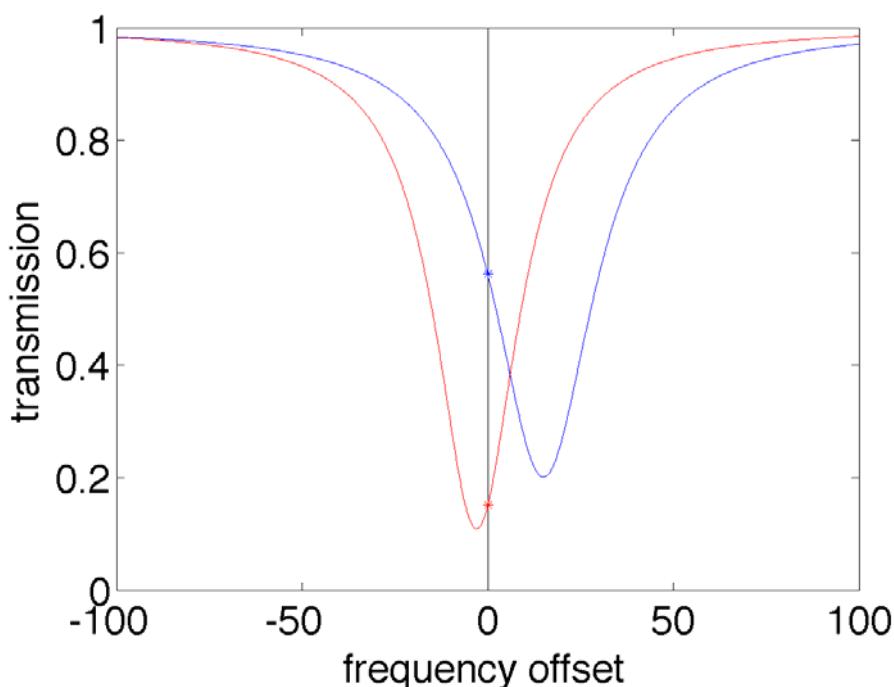
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

-1.5 °C



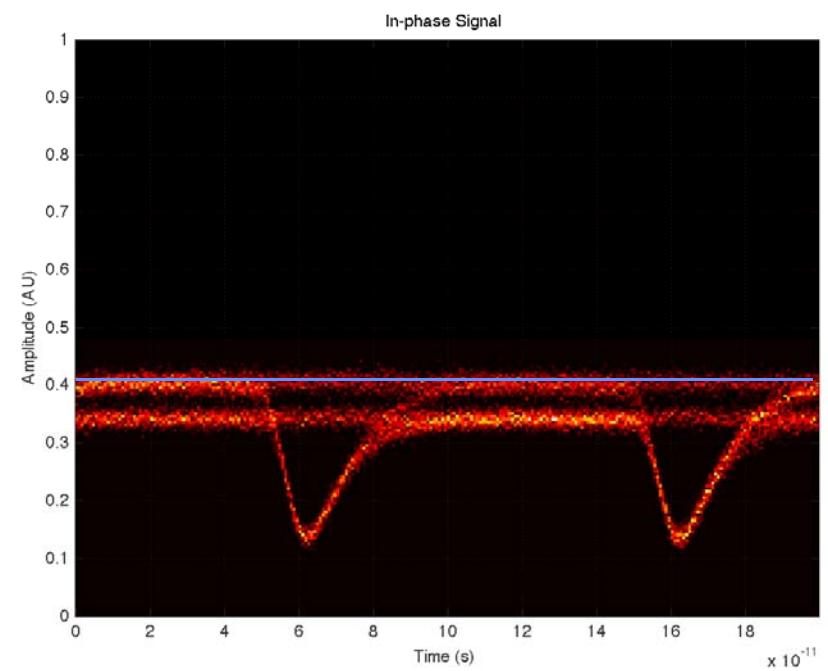
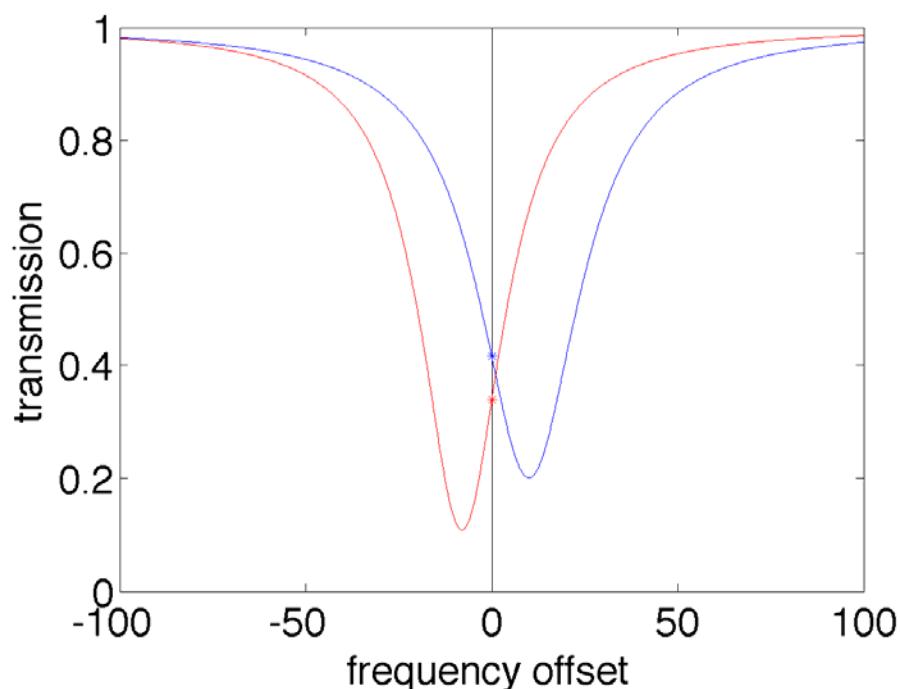
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

-1.0 °C



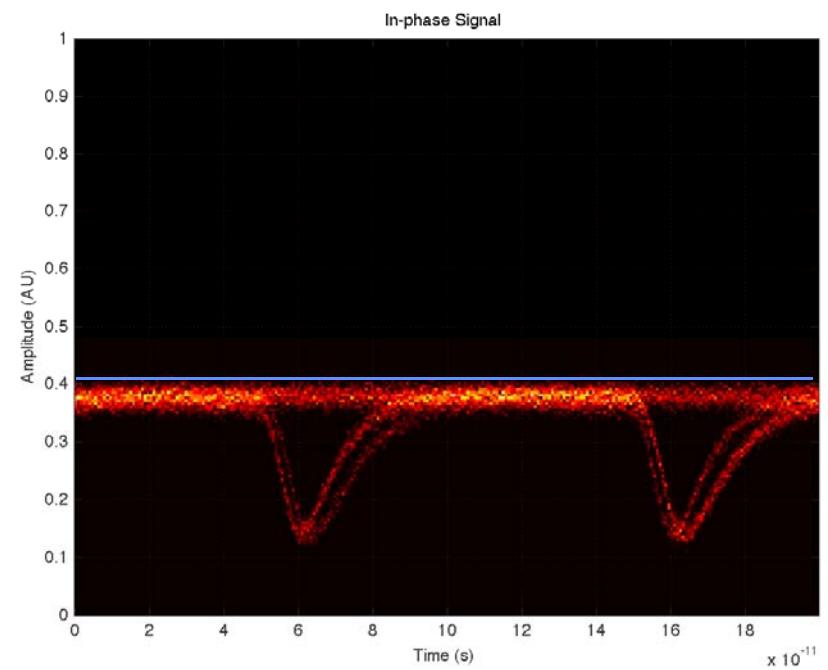
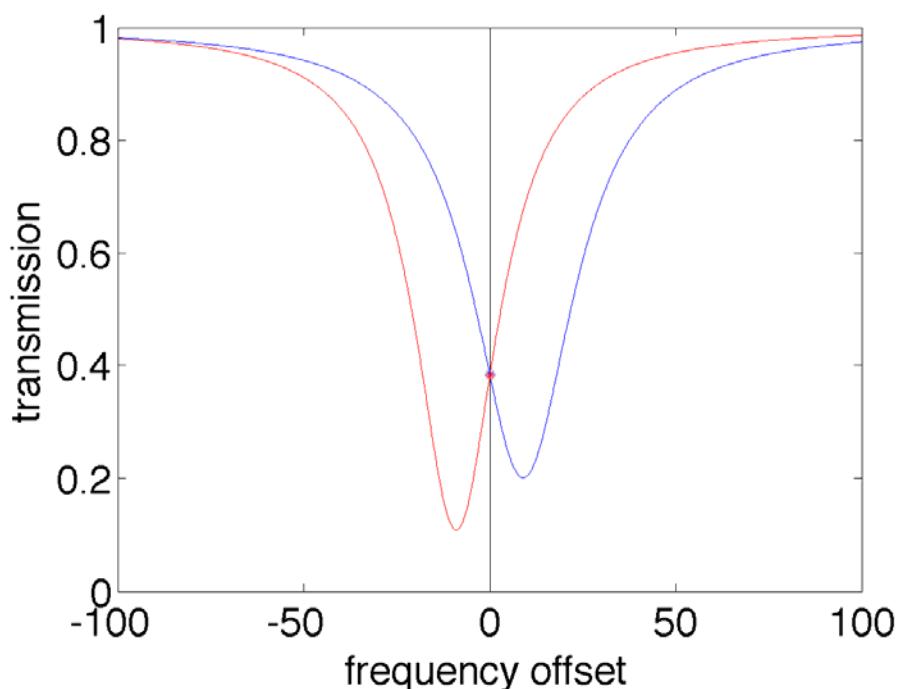
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

-0.9 °C



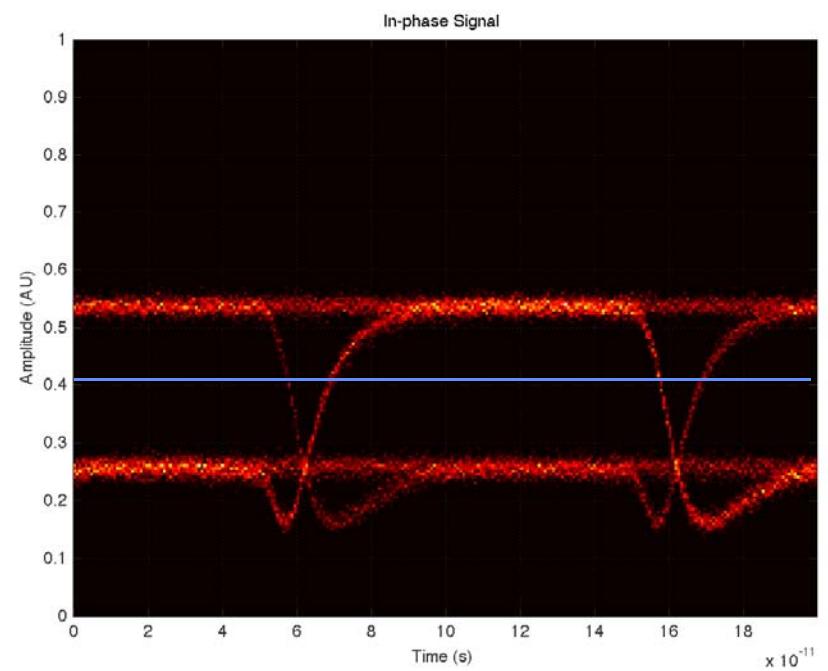
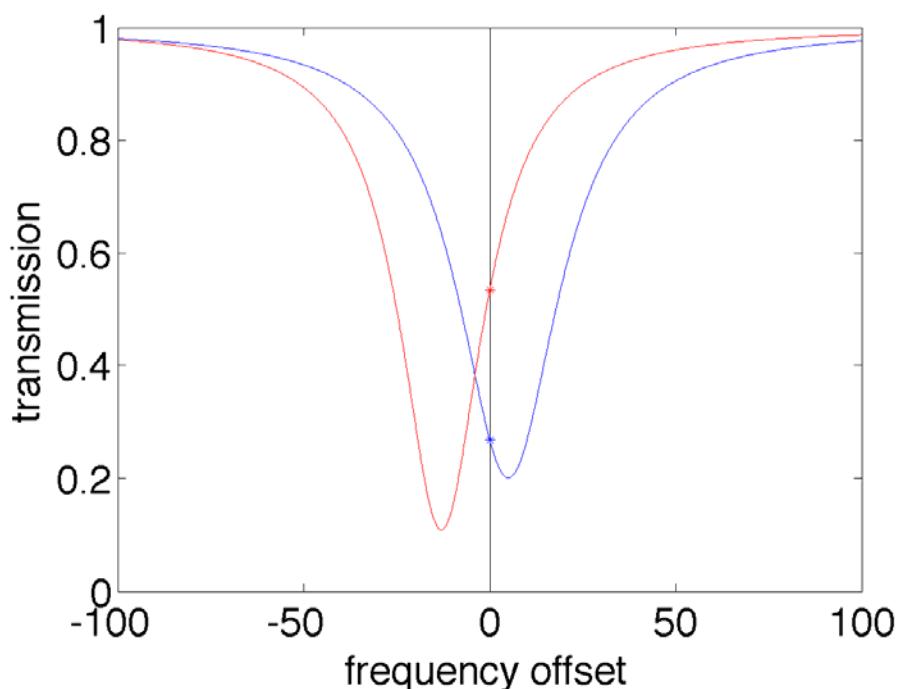
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

-0.5 °C



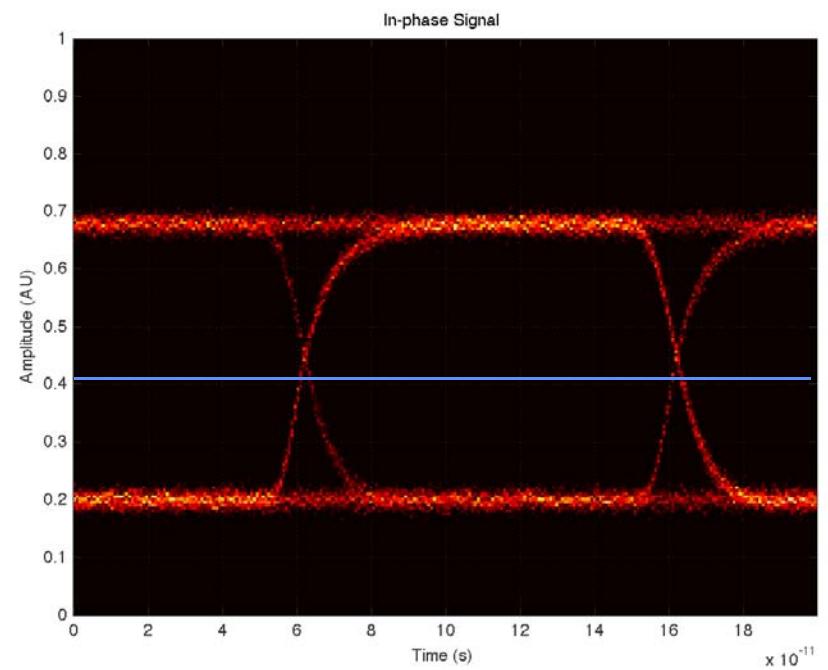
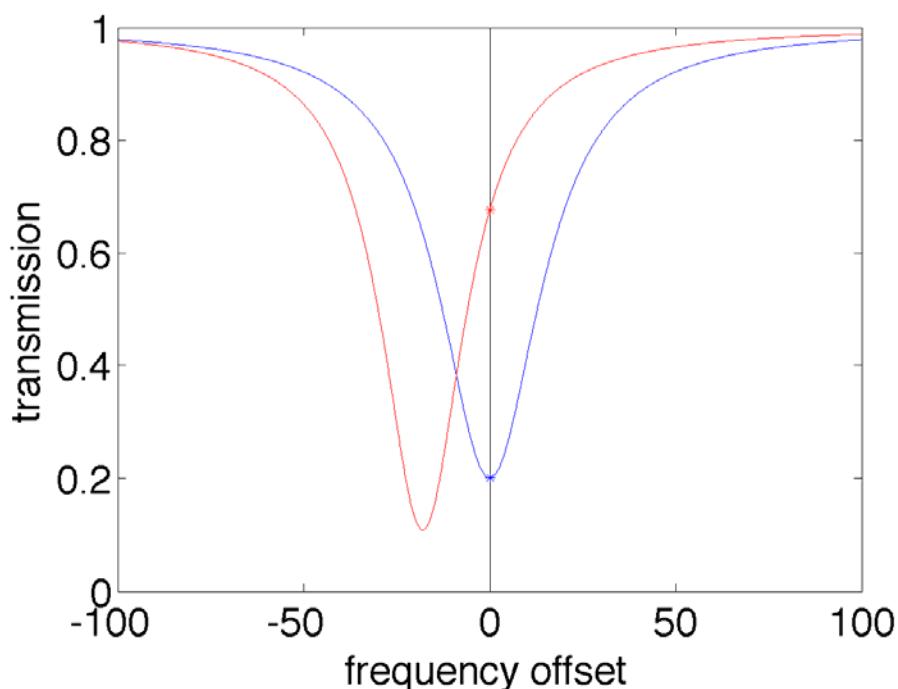
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

-0 °C



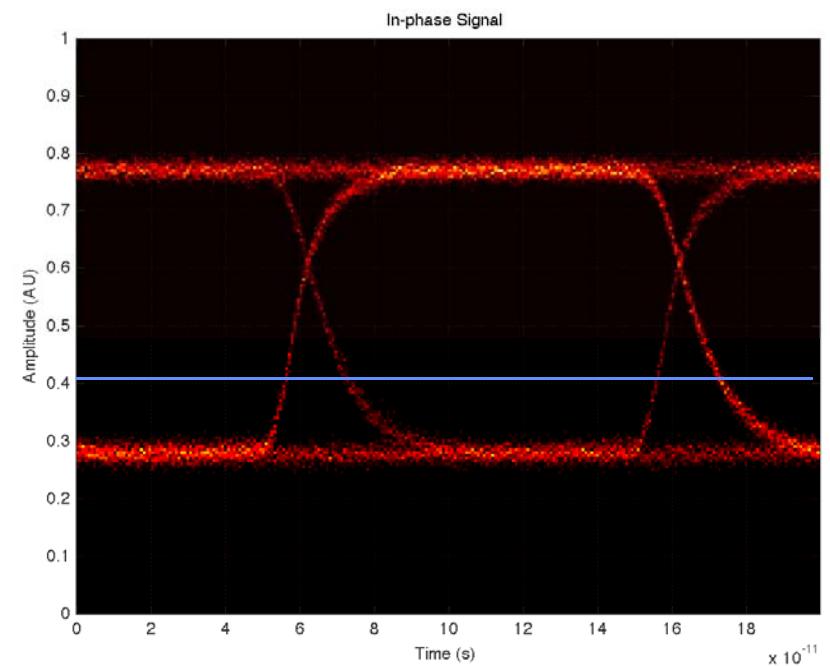
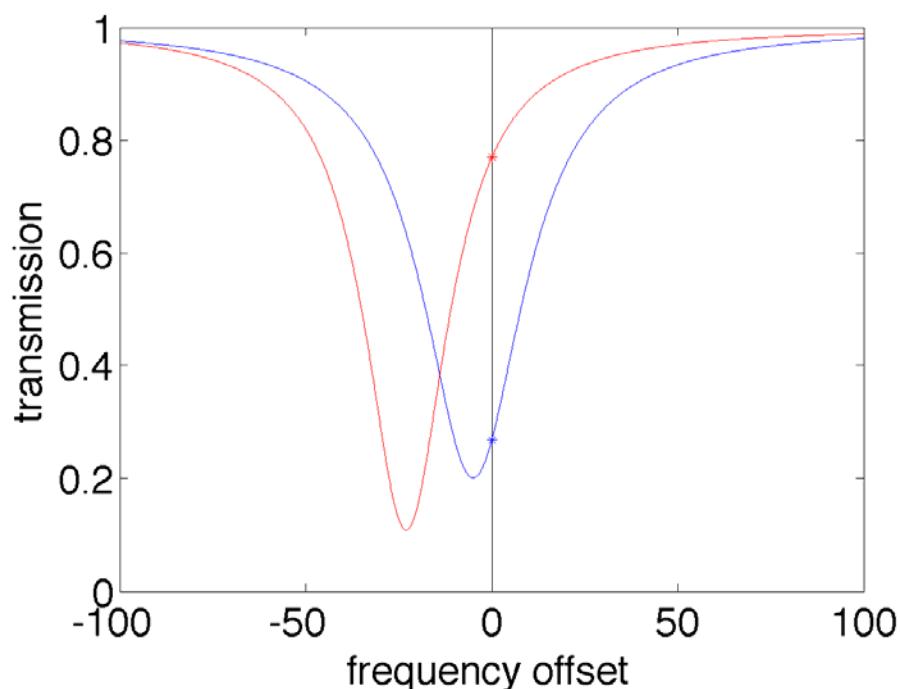
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

5 °C



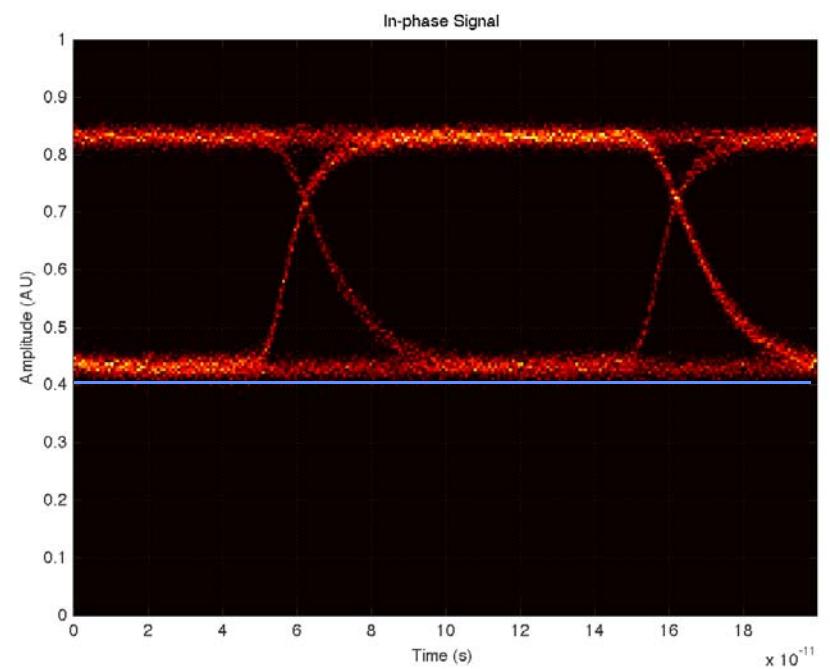
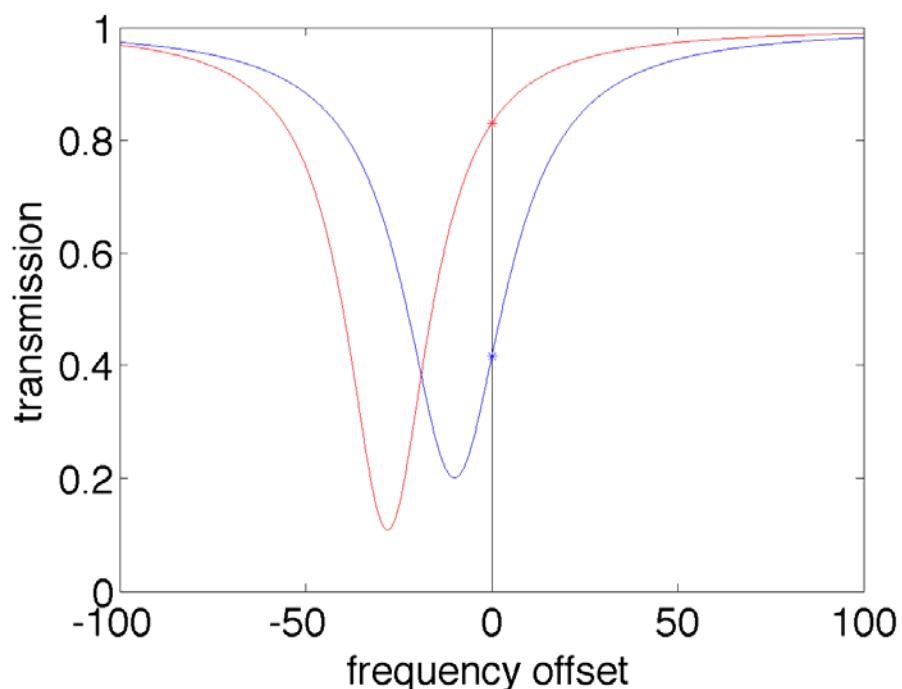
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

1 °C



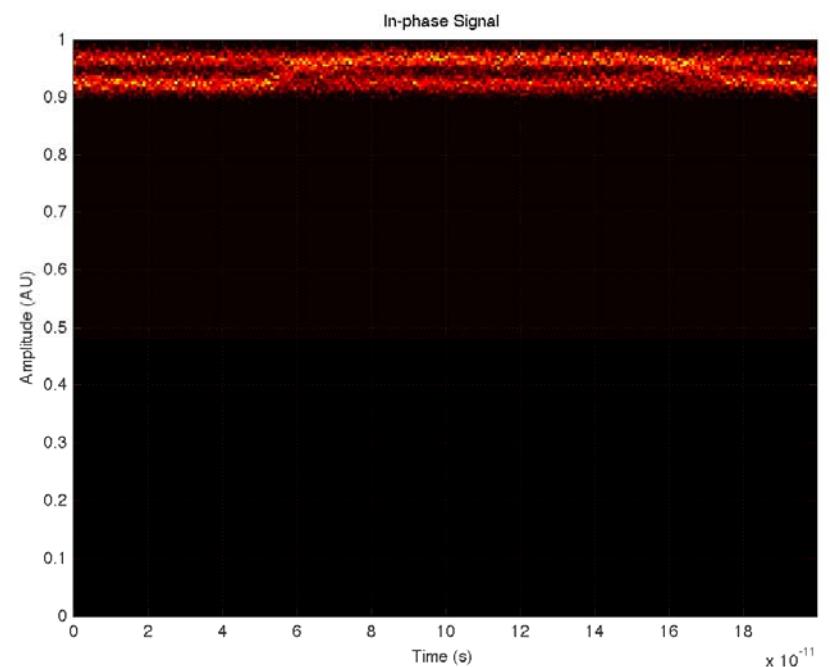
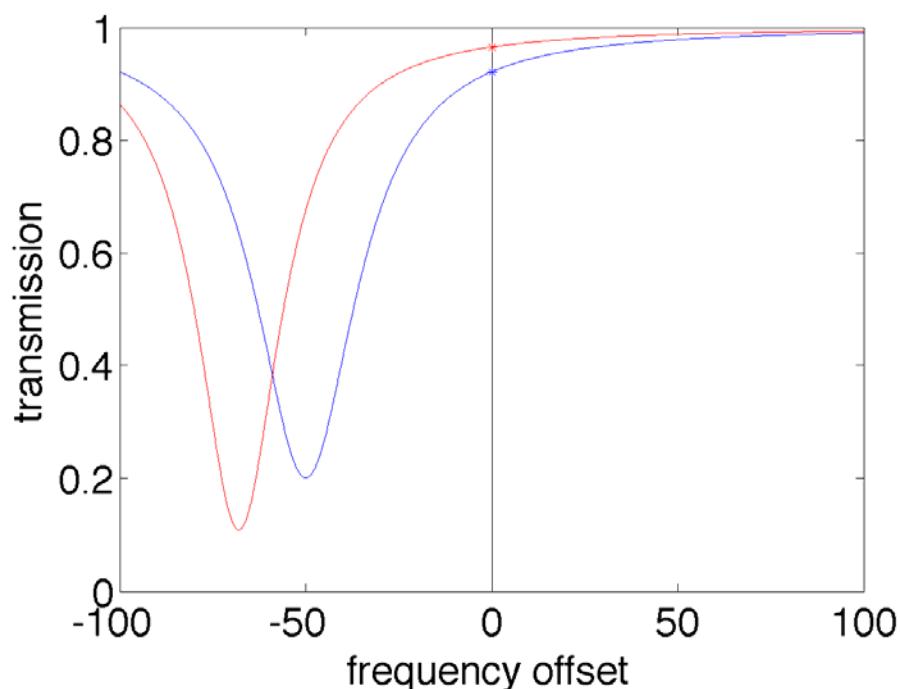
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

5 °C



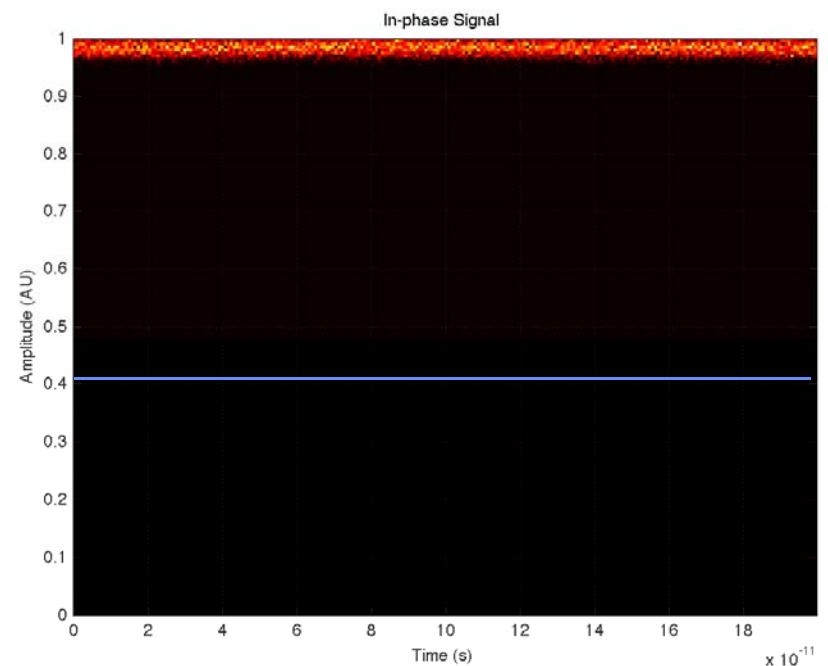
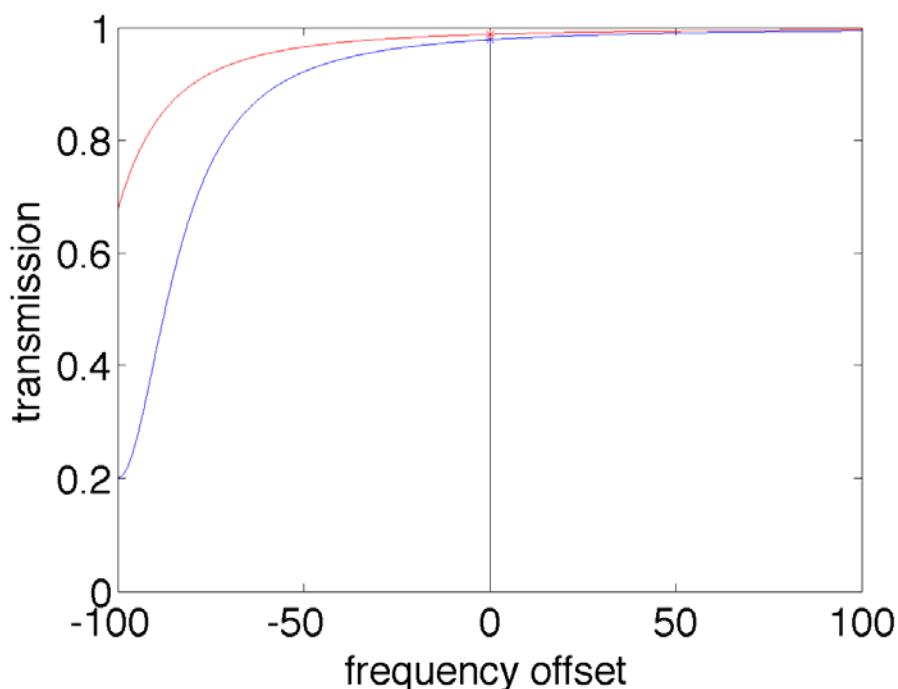
Red: Reverse Bias

Blue: Zero Bias

Resonant wavelength error

- Progression of simulated eye diagram with heating for an initial position colder than optimum

10 °C

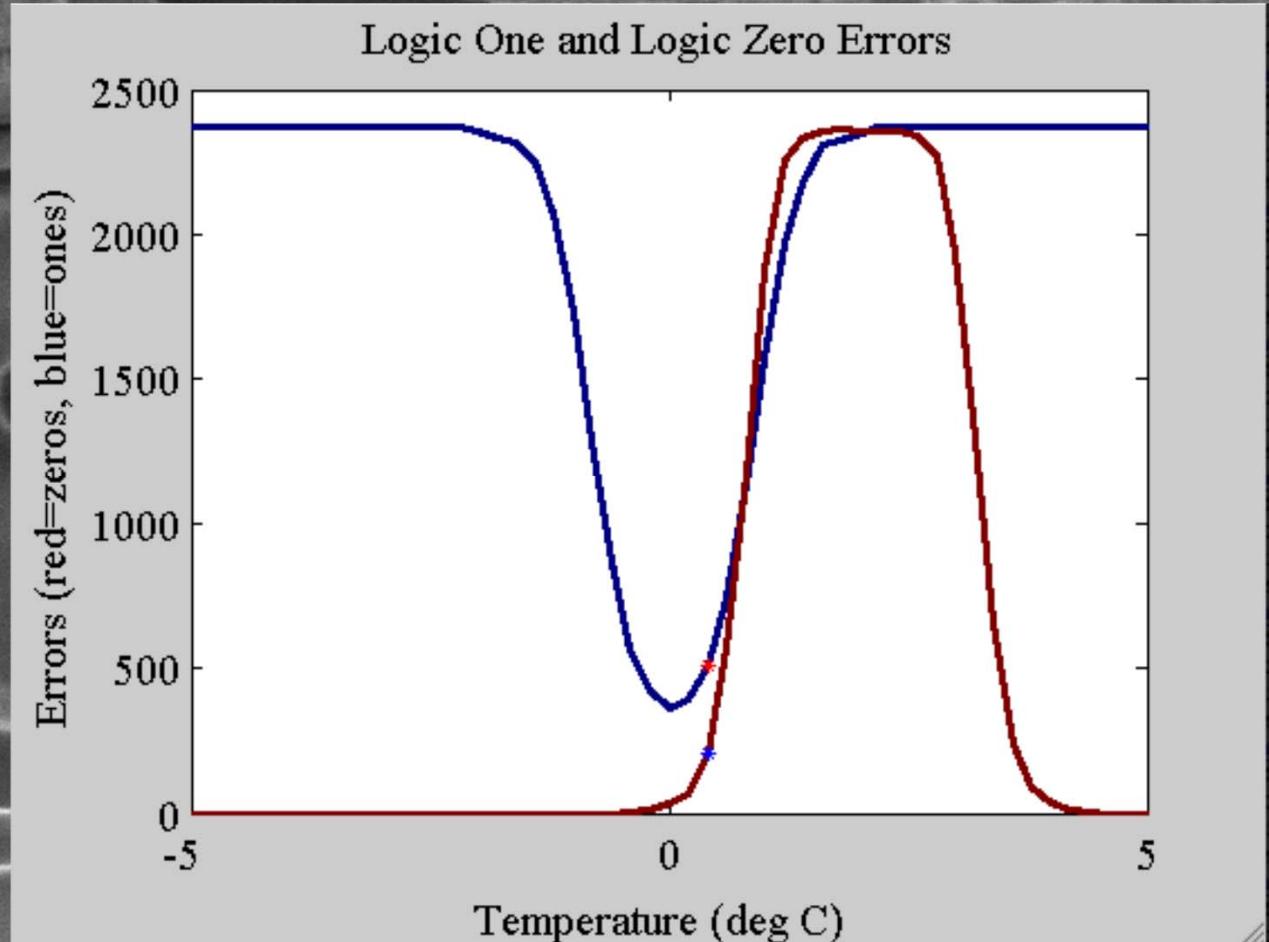


Red: Reverse Bias

Blue: Zero Bias

Logic one and logic zero errors

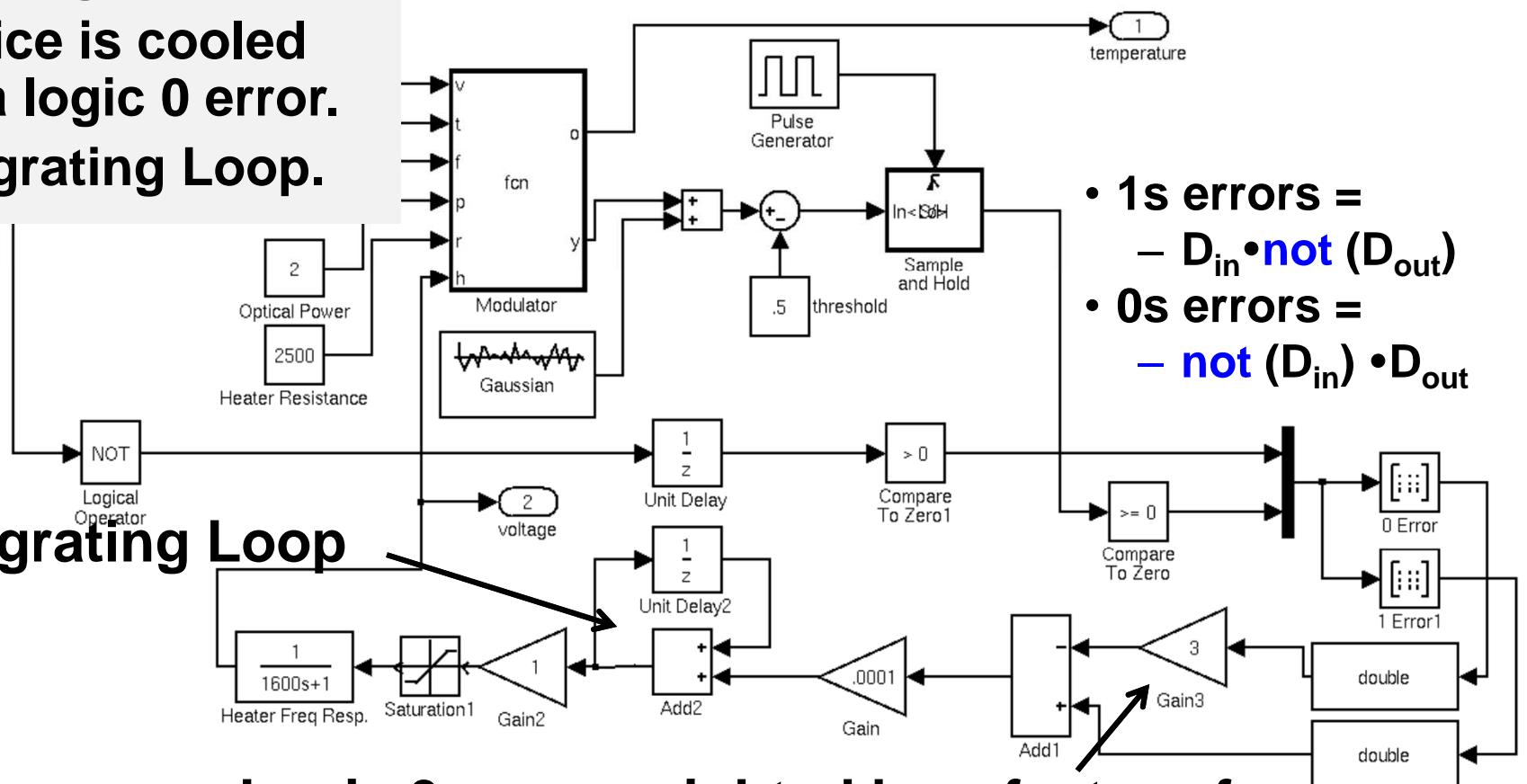
- Operating point ends up slightly off of the optimum without extra offset
- Overshoot requires a reset



Control logic (Simulink)

- Device is heated for a logic 1 error
- Device is cooled for a logic 0 error.
- Integrating Loop.

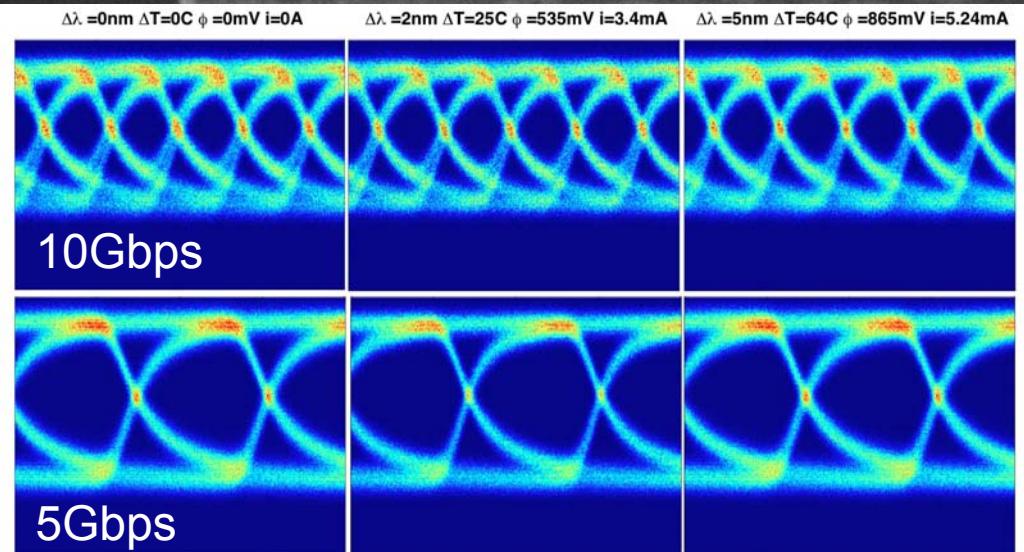
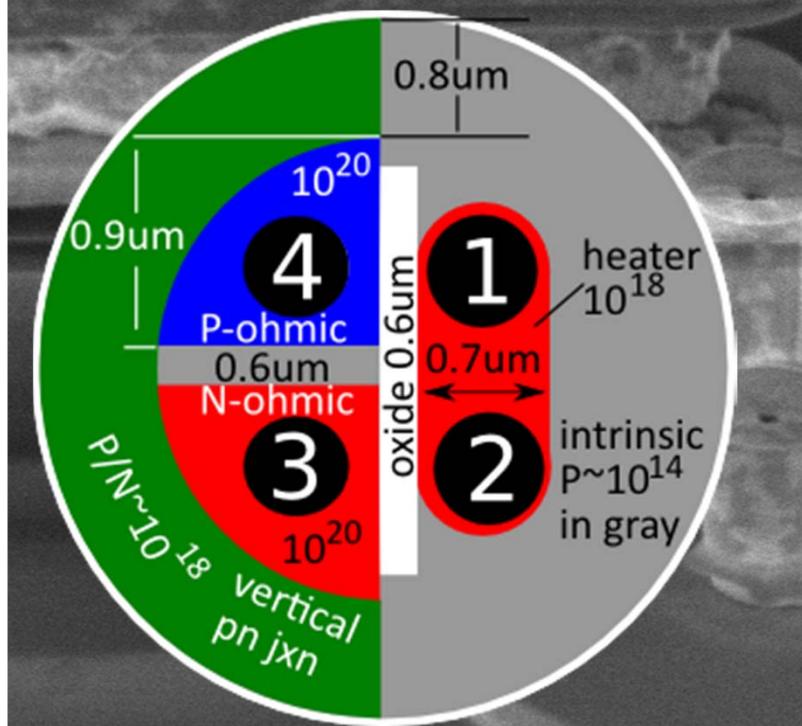
• Integrating Loop



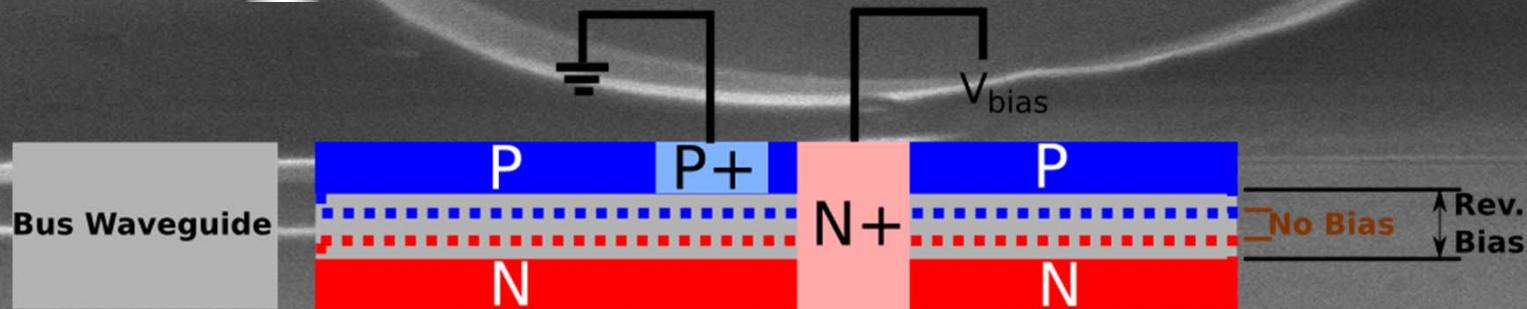
- Logic 0 error weighted by a factor of 3 to arrive at operating point.

- 1s errors =
 - $D_{in} \cdot \text{not } (D_{out})$
- 0s errors =
 - $\text{not } (D_{in}) \cdot D_{out}$

Heater-Modulator device

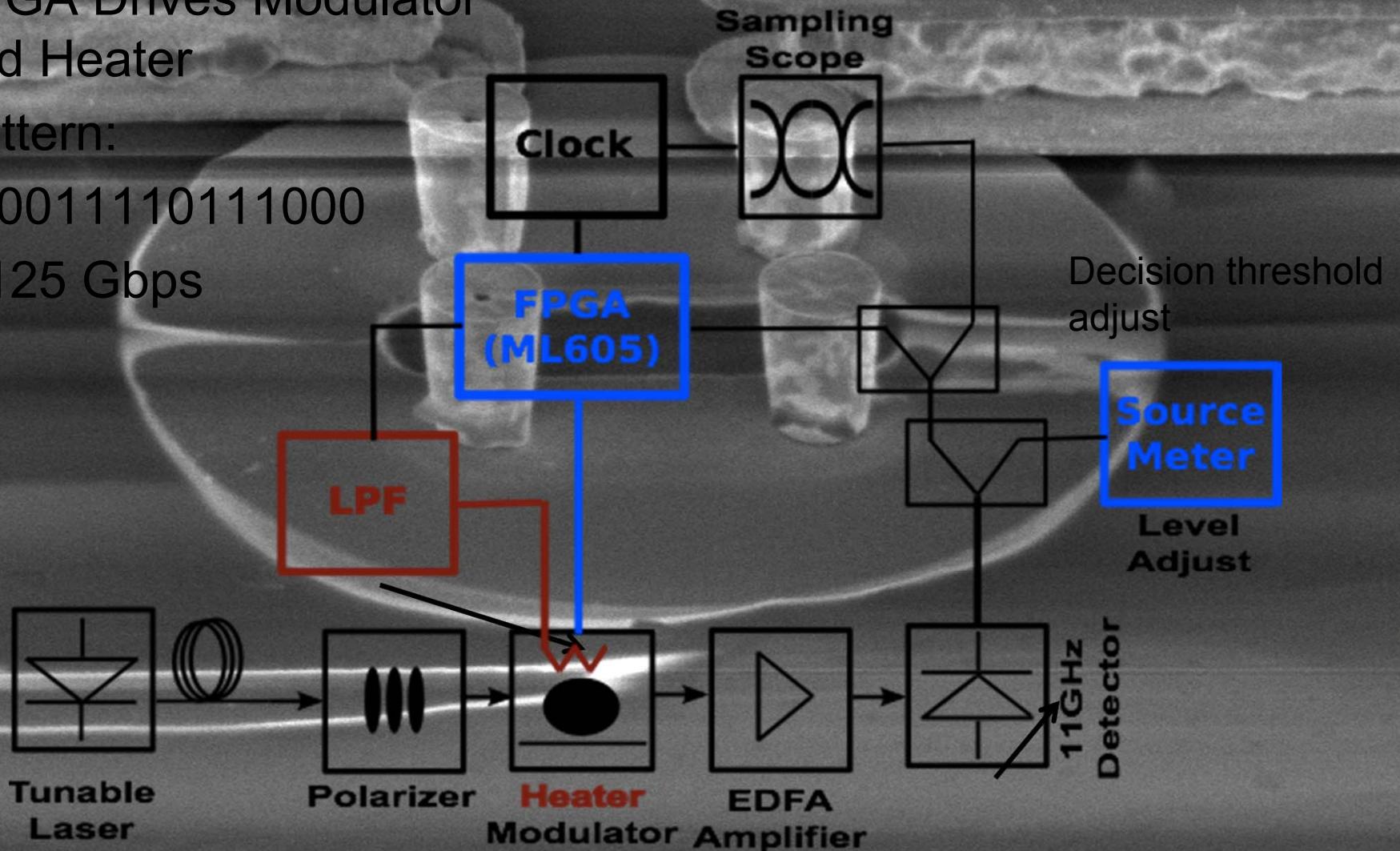


$\Delta\lambda = 2\text{nm}$ $\Delta\lambda = 5\text{nm}$



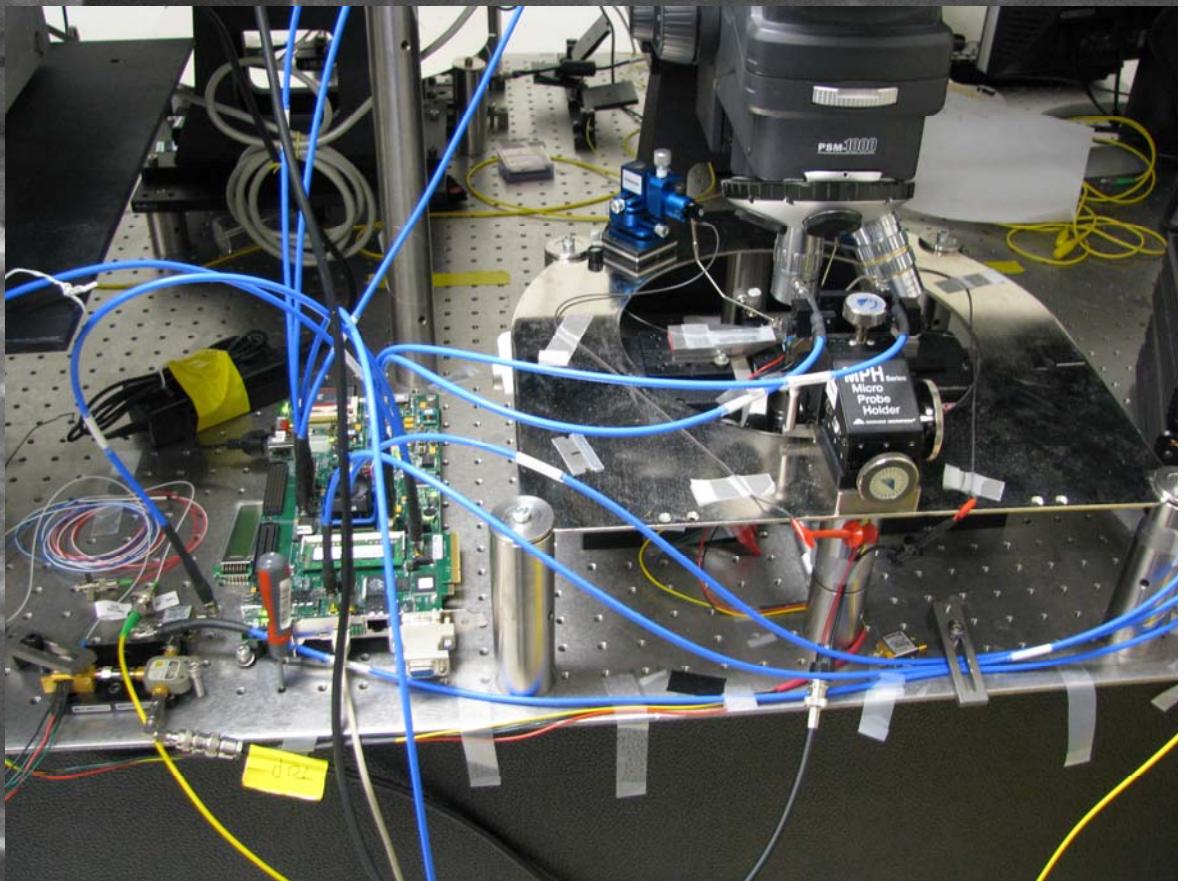
Experimental Set up

- FPGA Drives Modulator and Heater
- Pattern:
0100011110111000
- 3.125 Gbps

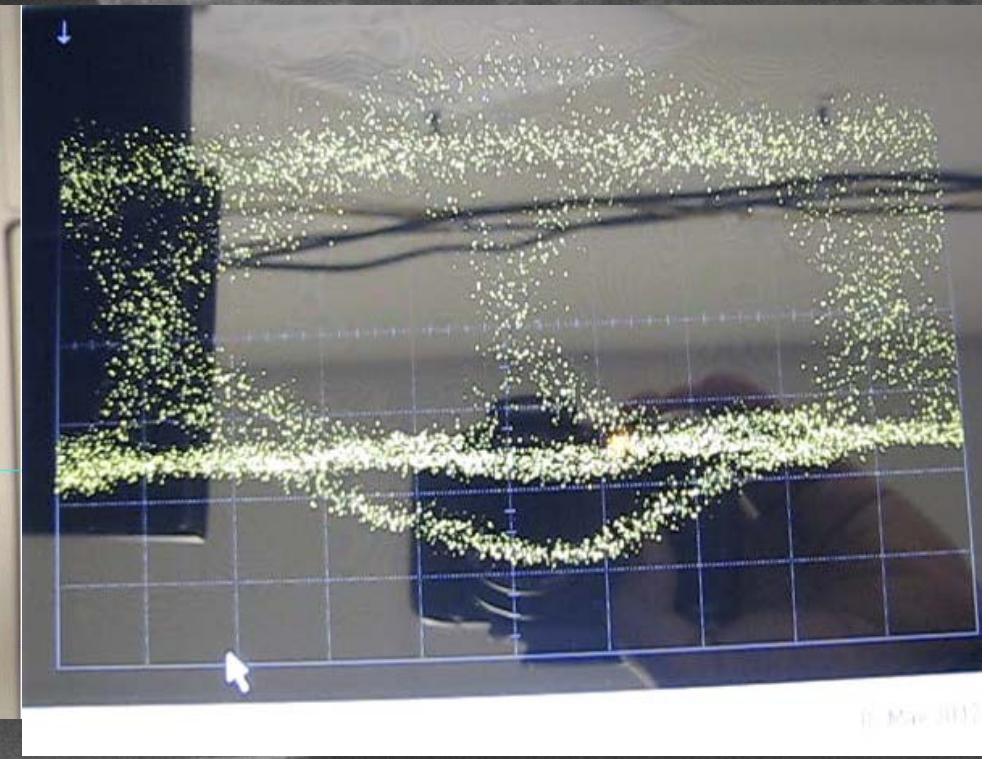


Experimental set up and results

- **Case 1: Initial wavelength is lower than resonant wavelength**
 - Tuning Range:
 - $25\text{C} (> 2\text{nm})$
 - Capable of 10 – 100 us tuning time.
- **Case 2: Device locked in the center of range**
 - Device cooled by 16 C in 10pm steps
 - Device heated by 16C
 - Device remained locked

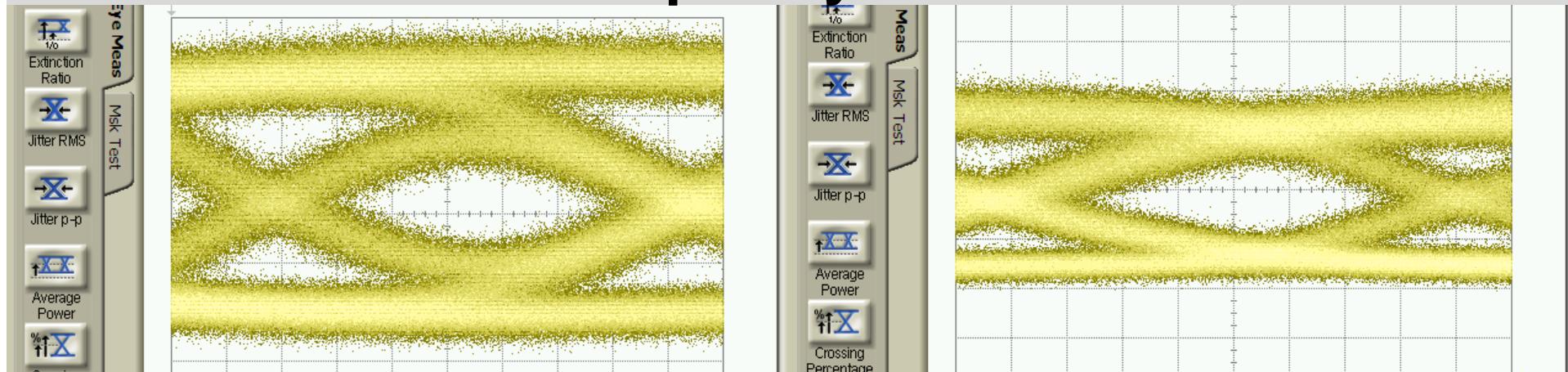


Experimental Results of Tuning



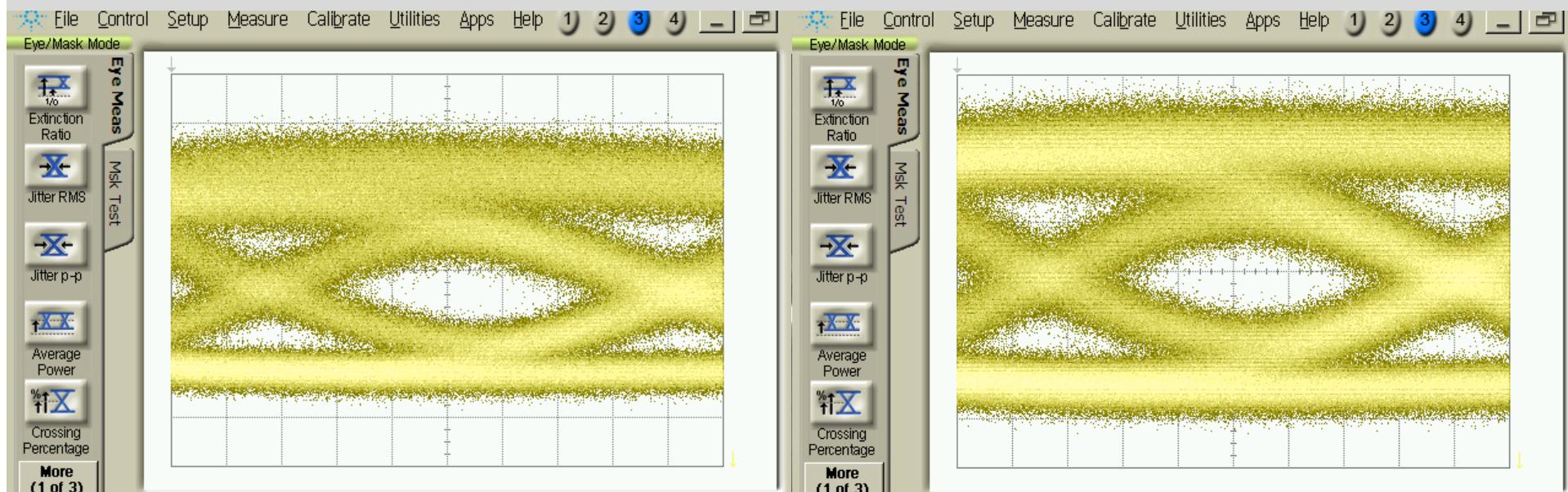
- Data rate = 3.125 Gbps
- Initial offset = 500 pm

Experimental results: Tuned eye with initial resonant frequency error



• 500 pm (62.5 GHz)

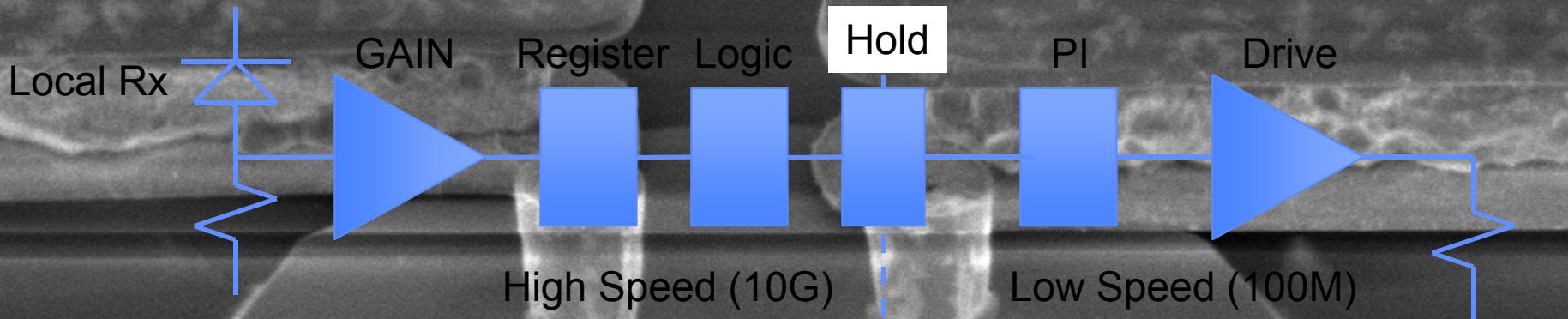
• 1000 pm (125 GHz)



• 1500 pm (187 GHz)

• 2000 pm (250 GHz)

Digital Wavelength Stabilization Electronics based on bit error measurement



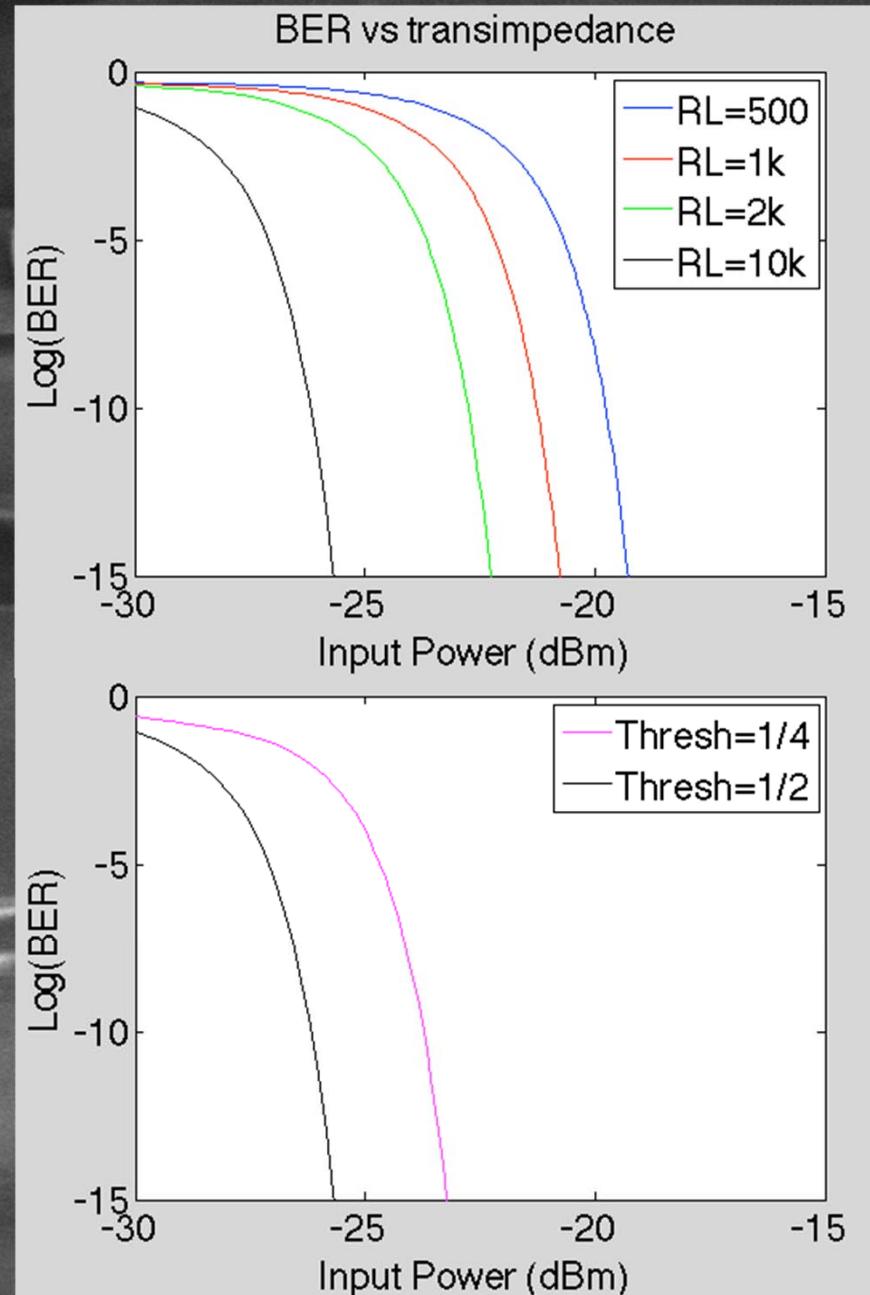
Idea

- Measure bit errors in a local receiver near the modulator
- Adjust heater to minimize local bit errors
- If local receiver has high noise floor, far-end receiver can be error free

- Control Loop
 - Rx: 10 fJ/bit * [can we do this?]
 - Register (5 fJ/bit)
 - Logic (<10 gate eq. 5 fJ/bit)
 - Hold (~ 20fJ/bit est.)
 - PI: < 10 fJ/bit (100X slower)
 - Actuation (Heater power)
- Example
 - $100G * 4.4\mu W/G = 44 \text{ fJ/bit} @ 10\text{Gbps} + 50 \text{ fJ/bit} = 90 \text{ fJ/bit}$

Receiver Noise

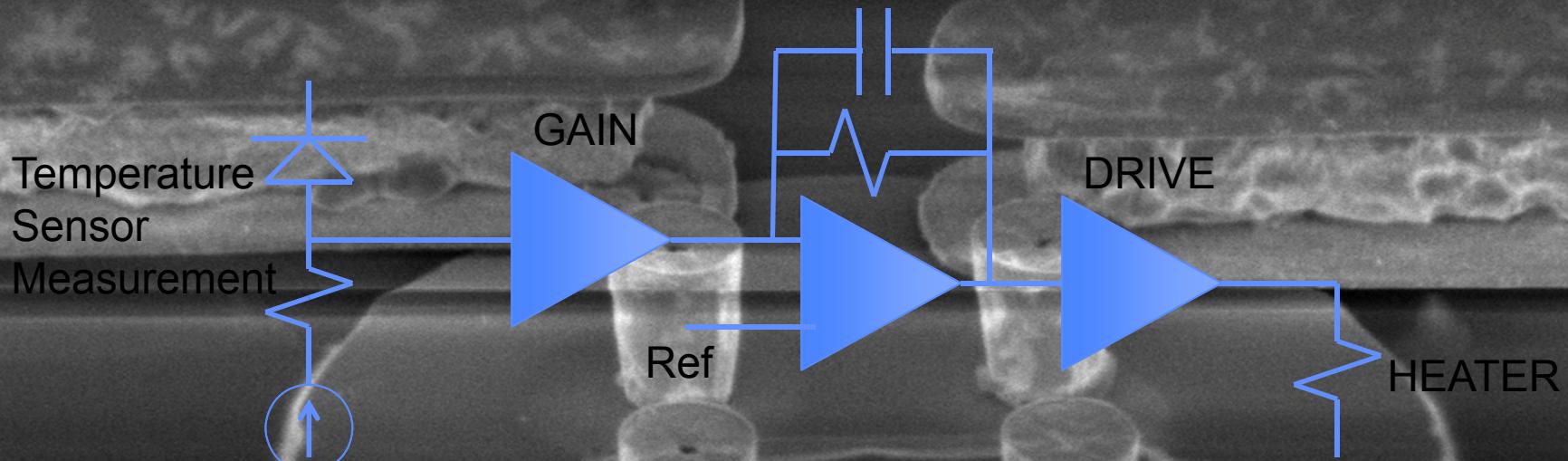
- How do we design a local receiver with higher noise than the remote receiver?
 - Lower transimpedance gain →
 - Higher power though
 - Different bias conditions
 - Different temperatures on resistors (micro-heaters)
 - Adaptive Threshold →
 - Different for '1' and '0'



Conclusion

- Preliminary demonstration of using bit errors from a local receiver to stabilize the resonant wavelength of a modulator
- Bit errors are what you really care about
 - Temperature, fabrication, aging, power, etc.
- Expect dissipation to be low in the circuit compared to the heater
- Still work to do
 - Full link showing error free operation at the receiver
 - Integration and robust low power operation

Analog Wavelength Stabilization Electronics



- **Control Loop**
 - Sensing & Gain ($10\mu\text{A}$ 1V)
 - PID Loop Circuitry ($10\mu\text{A}$ 1V)
 - Ref = $10\mu\text{A}$ 1V
 - Actuation (Heater power)

- **Example**

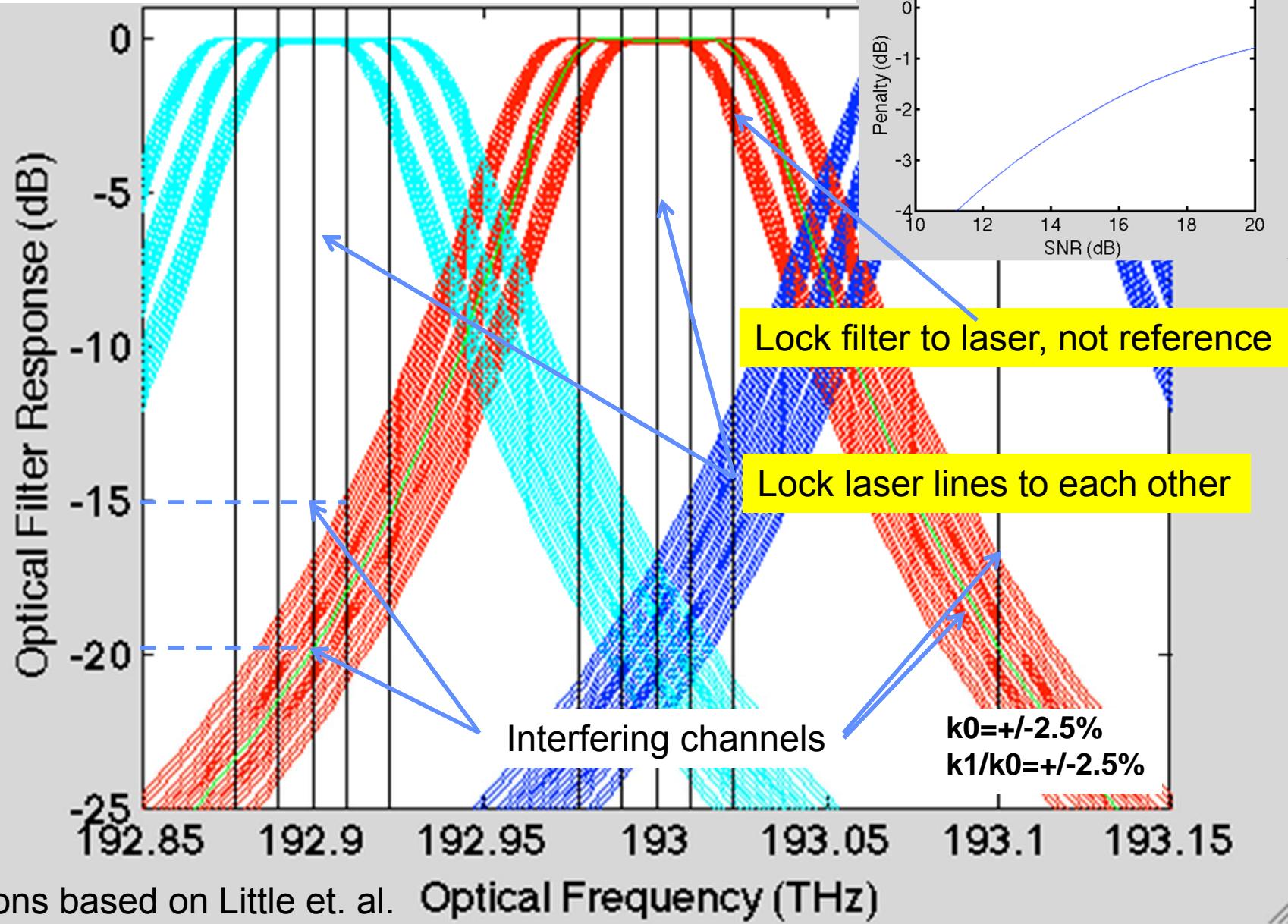
- $$- 100\text{G} * 4.4\mu\text{W/G} = 440\ \mu\text{W} + 30\mu\text{A} = 47\ \text{fJ/bit} @ 10\text{Gbps}$$

Based on C. T. DeRose et. al., CLEO 2010



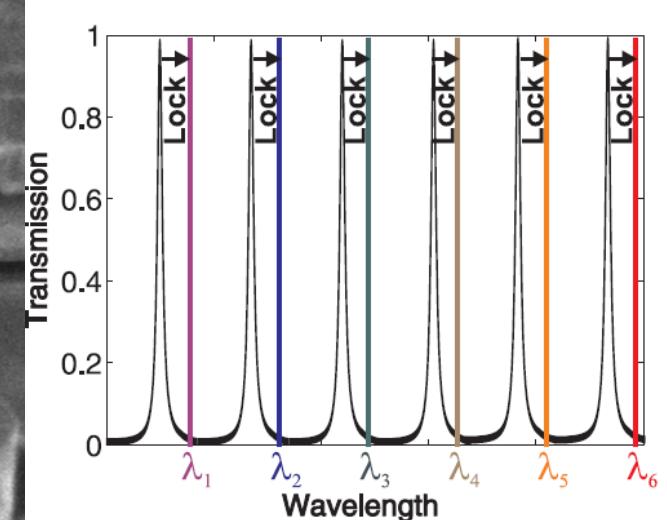
Temperature Changes – 2nd order filter

100 GHz channel spacing, 12.5 GHz laser stability, 10 Gb/s

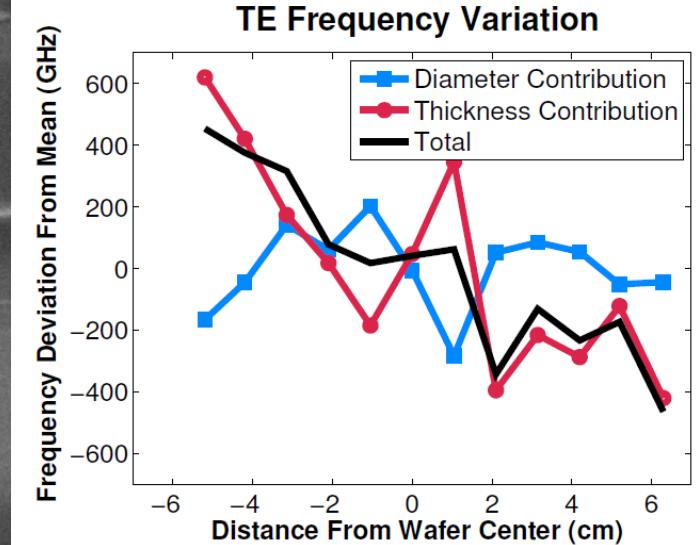


Wavelength Recovery and manufacturing tolerances

- Thermal variations
 - DWDM: alignment of resonators to specific lines, not quite as simple as single resonators
- Manufacturing
 - We think thickness is more of an issue than dimensions (for disks)
 - What is the ultimate limit of manufacturing wavelength variation?
 - Can it be post-processed?



picture from M. Watts, HSD 2011



See also:

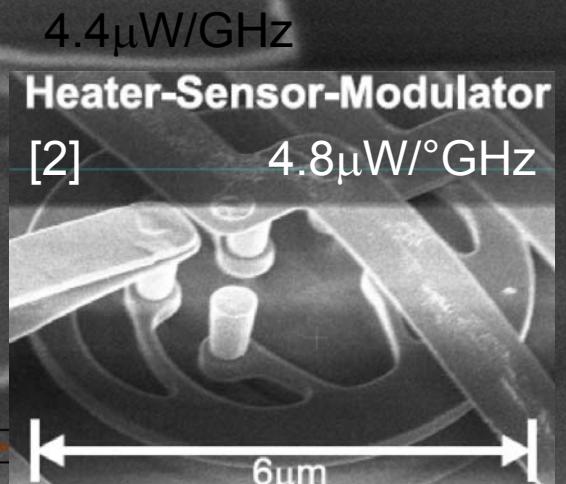
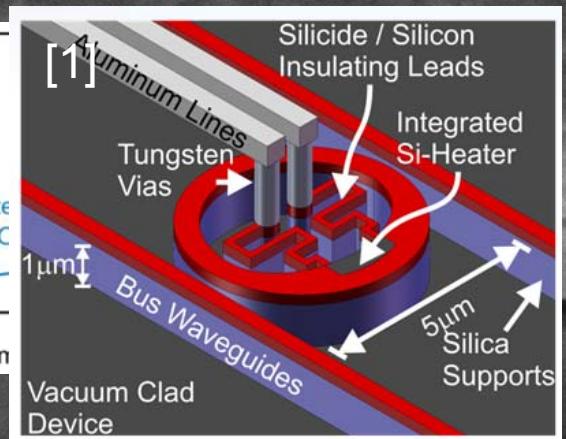
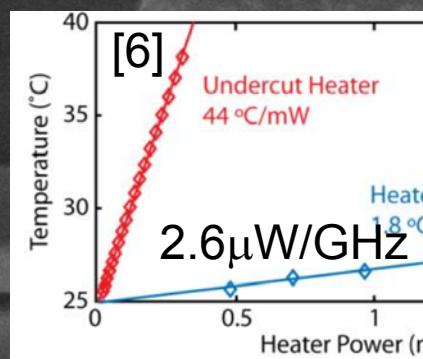
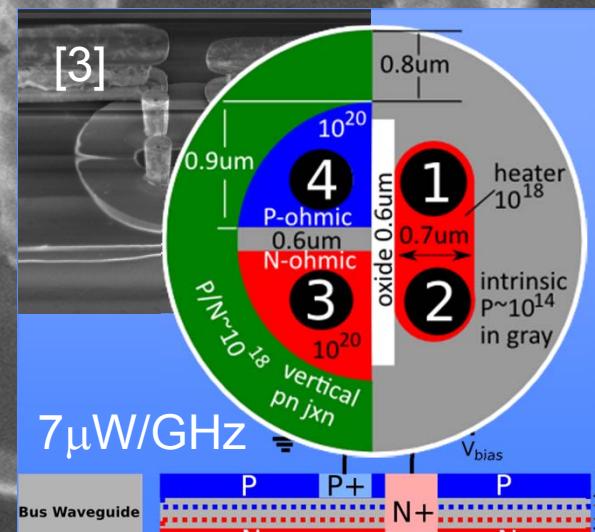
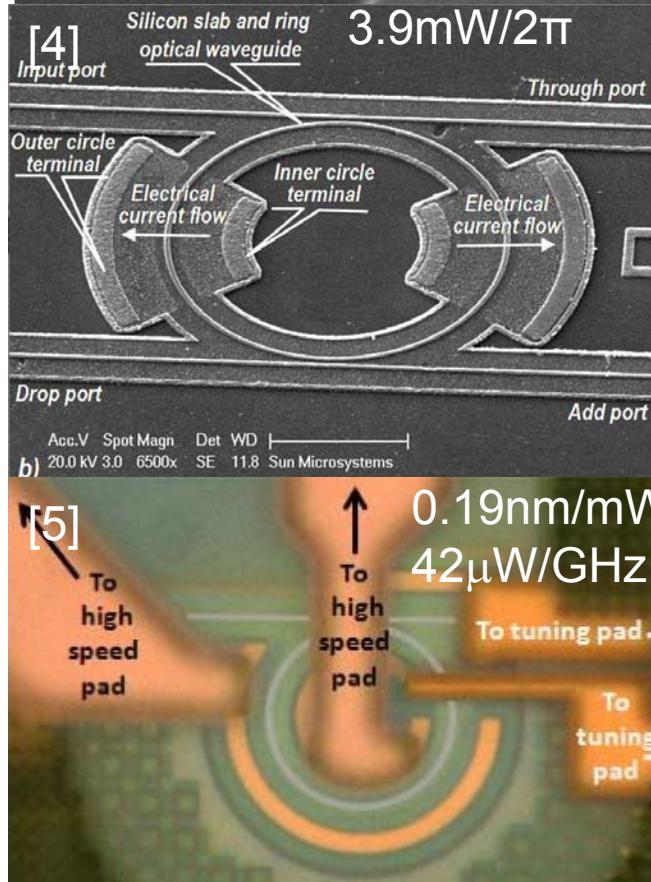
A. V. Krishnamoorthy et. al., IEEE Photonics Journal, 2011

M. Gorgas et. al., IEEE CICC, 2011

W. A. Zortman et. al., Optics Express (2010)

Wavelength Stabilization Devices

- Device Concepts
 - Heater-filters
 - Heater-modulators
 - Heater-sensor-modulators



1. M. R. Watts et. al., CLEO 2009
2. C. T. DeRose et. al., CLEO 2010
3. W. A. Zortman et. al., OFC 2012
4. J. E. Cunningham et. al., Optics Express, 2010
5. G. Li et. al., Optics Express 2011
6. J. S. Orcott et. al., Optics Express 2011